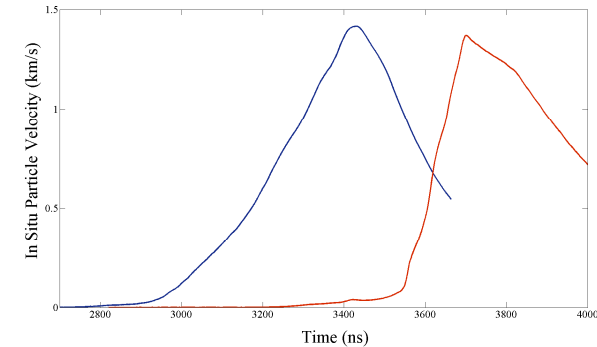
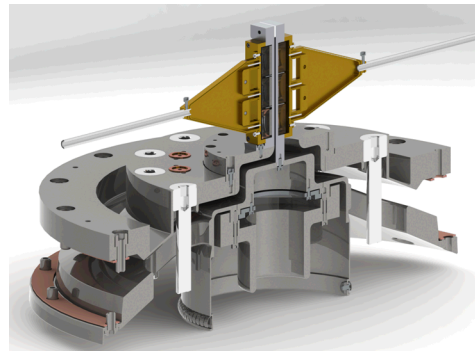
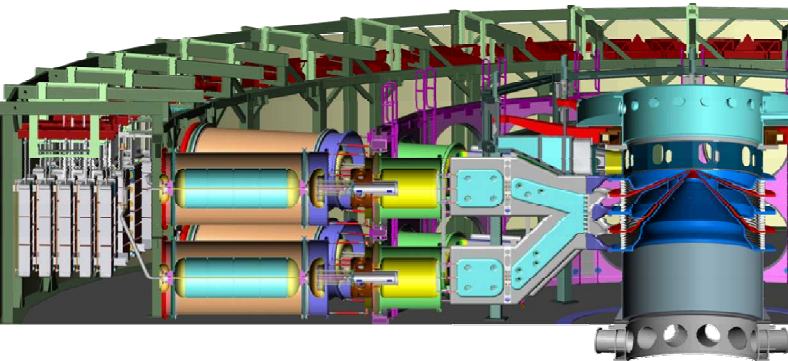


Exceptional service in the national interest



Extracting Strength from Ramp-Release Experiments on Z

Justin Brown

SCCM July 8, 2013

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Scott Alexander
Jim Asay
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Rate-Dependent Simulations

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MHD Discussions

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Beryllium Experiments

Marcus Knudson

Monte Carlo Methodology

Dan Dolan

Target Design

Dustin Romero
Devon Dalton

Diagnostics

Charlie Meyer

What is strength?



$$\bar{\sigma} = \begin{bmatrix} \sigma_x & \sigma_{xy} & \sigma_{xz} \\ \sigma_{xy} & \sigma_y & \sigma_{yz} \\ \sigma_{xz} & \sigma_{yz} & \sigma_z \end{bmatrix}$$

$$P = \frac{\sigma_{kk}}{3}$$

Pressure (EOS)

$$\bar{S} = \bar{\sigma} - P\bar{I}$$

stress deviator (strength)



- Can find an equivalent deviatoric stress using J2 / von Mises flow theory:

$$\sigma_Y = \sqrt{\frac{3}{2} S_{ij} S_{ij}}$$

$\sigma_Y \leq Y(\bar{\sigma}, \bar{\epsilon}, \dot{\bar{\epsilon}}, T, \xi) \longrightarrow$ Elastic
 $\sigma_Y > Y(\bar{\sigma}, \bar{\epsilon}, \dot{\bar{\epsilon}}, T, \xi) \longrightarrow$ Plastic, $\sigma_y = Y$

Uniaxial strain mechanics

$$\bar{\epsilon} = \begin{bmatrix} \epsilon_x & 0 & 0 \\ 0 & 0 & 0 \\ 0 & 0 & 0 \end{bmatrix} \longrightarrow \bar{\sigma} = \begin{bmatrix} \sigma_x & 0 & 0 \\ 0 & \sigma_y & 0 \\ 0 & 0 & \sigma_y \end{bmatrix}$$

$$P = \frac{\sigma_x + 2\sigma_y}{3}$$

$$\bar{S} = \begin{bmatrix} \frac{2}{3}(\sigma_x - \sigma_y) & 0 & 0 \\ 0 & \frac{1}{3}(\sigma_y - \sigma_x) & 0 \\ 0 & 0 & \frac{1}{3}(\sigma_y - \sigma_x) \end{bmatrix}$$

- Uniaxial strain results in a simplified yield criteria:

$$\sigma_Y = \sqrt{\frac{3}{2} S_{ij} S_{ij}} = \sigma_x - \sigma_y$$

If deformation is plastic (on the yield surface):

$$Y = \sigma_x - \sigma_y = 2\tau$$

$$\sigma_x = P + \frac{2}{3} Y$$

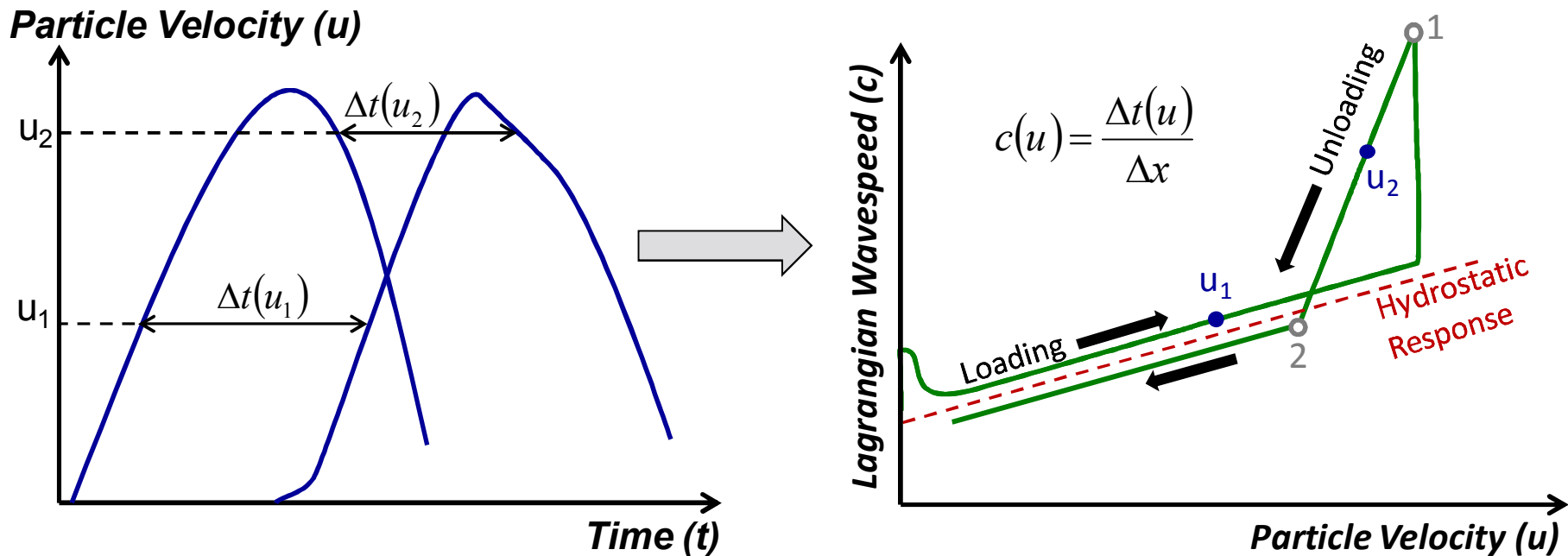
Outline

- Background/Theory
 - Self-consistent method
 - Corrections
 - Mean pressure
 - Attenuation
 - Rate effects
 - Window : transfer function

- Experiments
 - Analysis of a typical Z strength experiment
 - Extracting a point on the yield surface
 - Results for T_a

Experimental observables and Lagrangian analysis

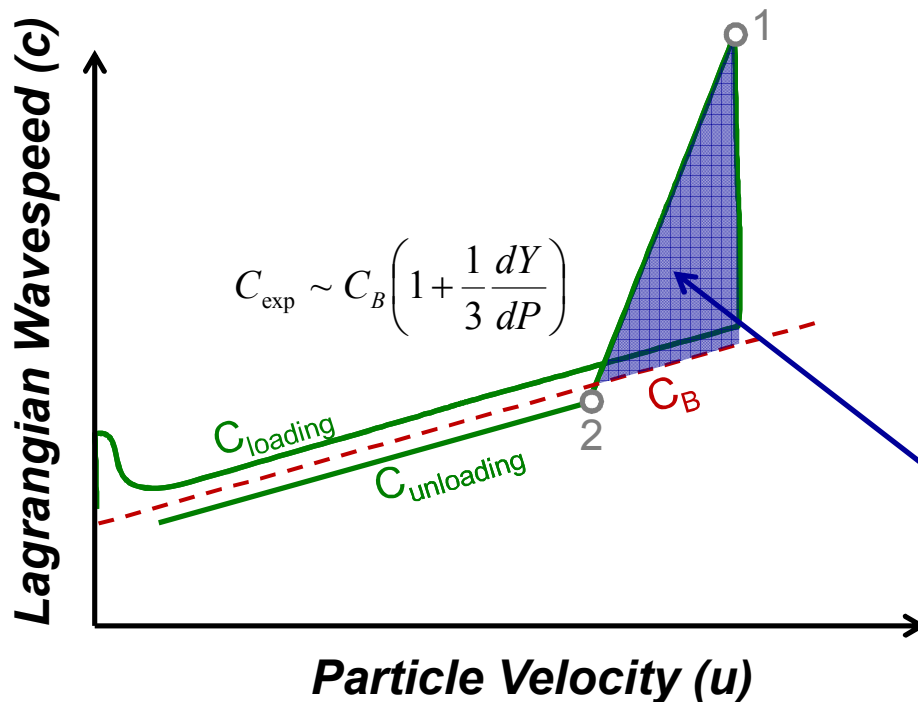
- Line outs of *in situ* particle velocities at 2 thicknesses give corresponding wavespeeds.
 - Assumption of simple wave propagation



How we are measuring strength: self-consistent method

- Advantages

- Requires only 1D loading and velocimetry
- No pressure restrictions



- Assumptions

- Rate-independent response
- J2 plasticity (Von-Mises yield)

- Uniaxial strain results in simplified coupling:

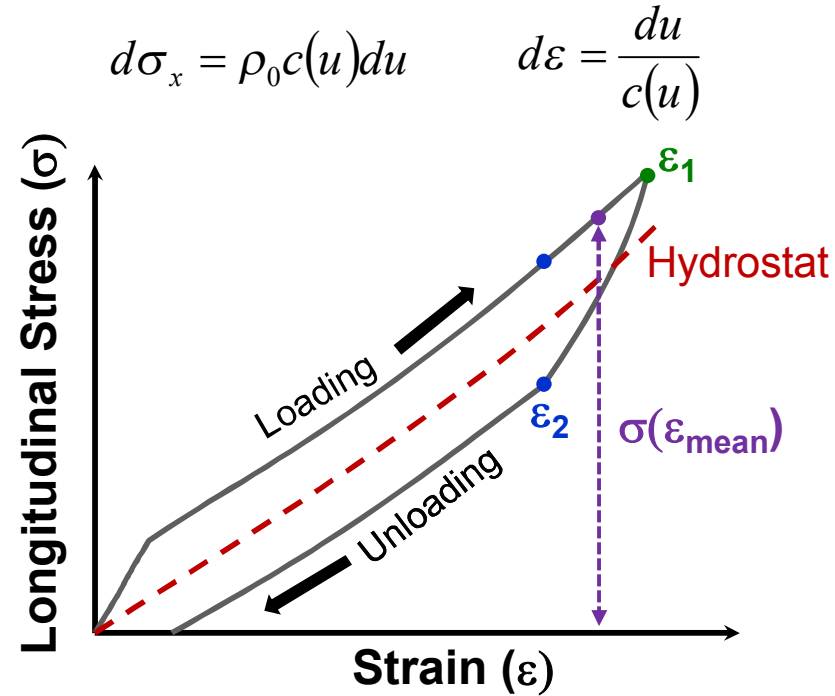
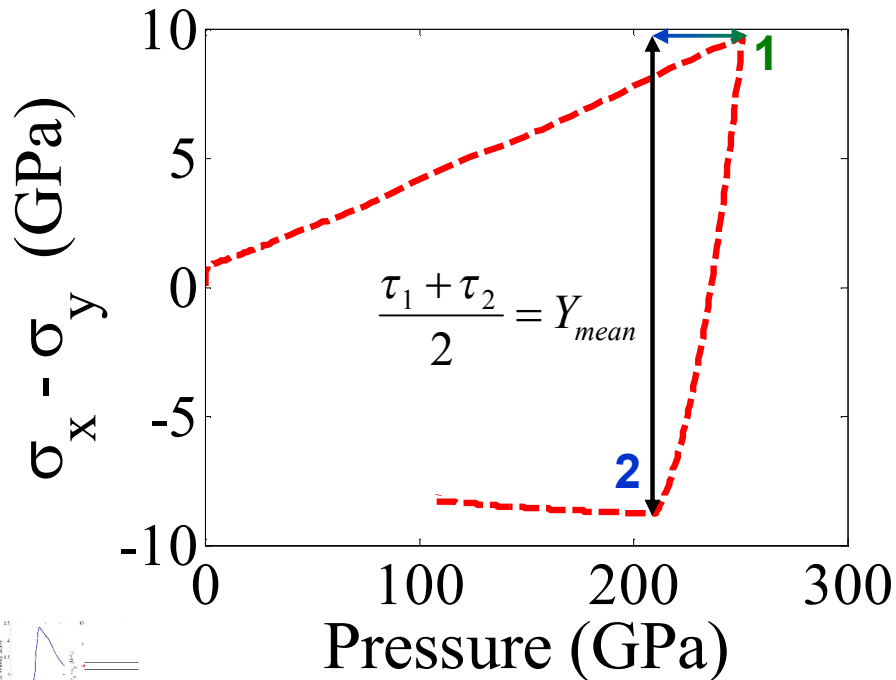
$$\sigma_x(\varepsilon) = P(\varepsilon) + \frac{4}{3}\tau(\varepsilon)$$

$$\frac{d\tau}{d\varepsilon} = \frac{3}{4}\rho_0 [c_{\text{exp}}^2 - c_B^2]$$

$$\tau_2 - \tau_1 = \frac{3}{4}\rho_0 \int_{u_1}^{u_2} [c_{\text{exp}}^2 - c_B^2] \frac{du}{c}$$

A closer look at the interpretation: mean yield strength and pressure

- Material unloads from the upper to lower yield surface over a finite pressure range

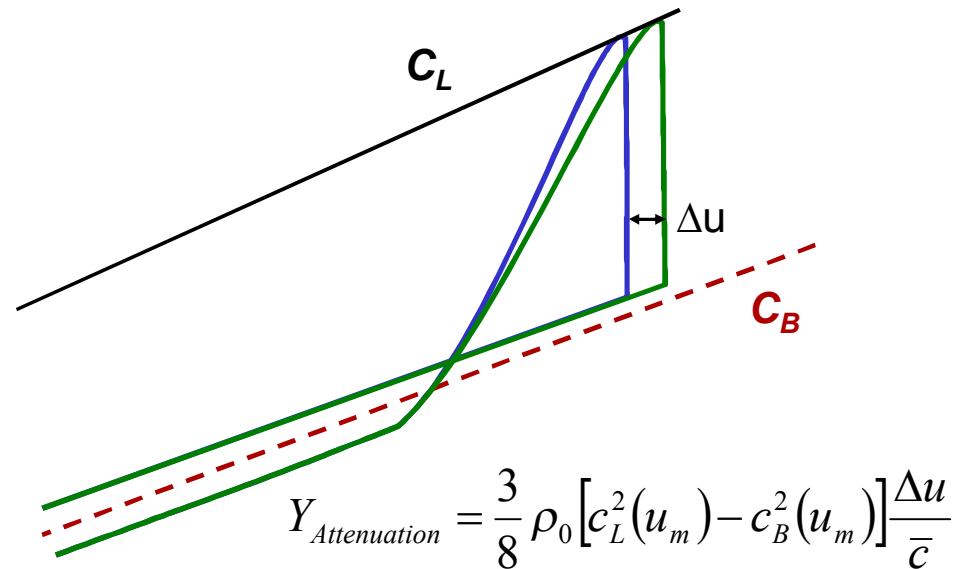
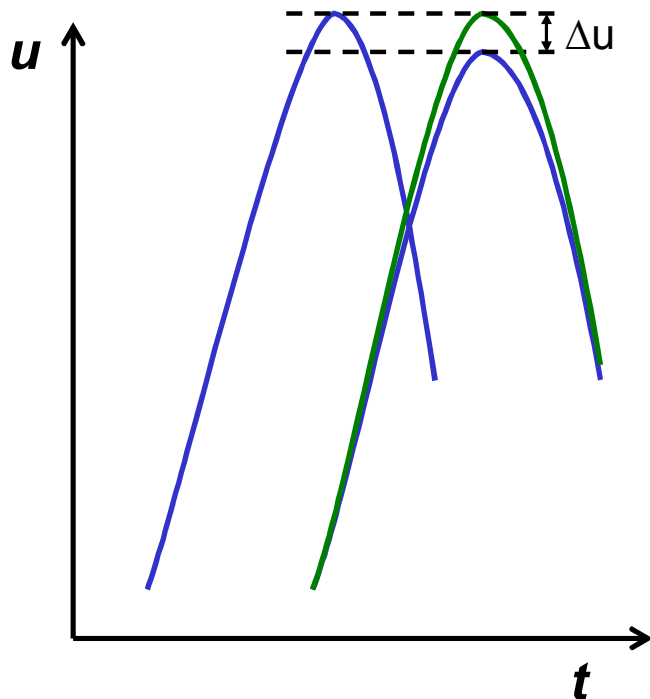


Assuming linearity of the yield surface over the unloading pressure regime:

$$\tau_{mean} = \frac{\tau(\epsilon_1) + \tau(\epsilon_2)}{2} = \tau\left(\frac{\epsilon_1 + \epsilon_2}{2}\right) = \tau(\epsilon_{mean})$$

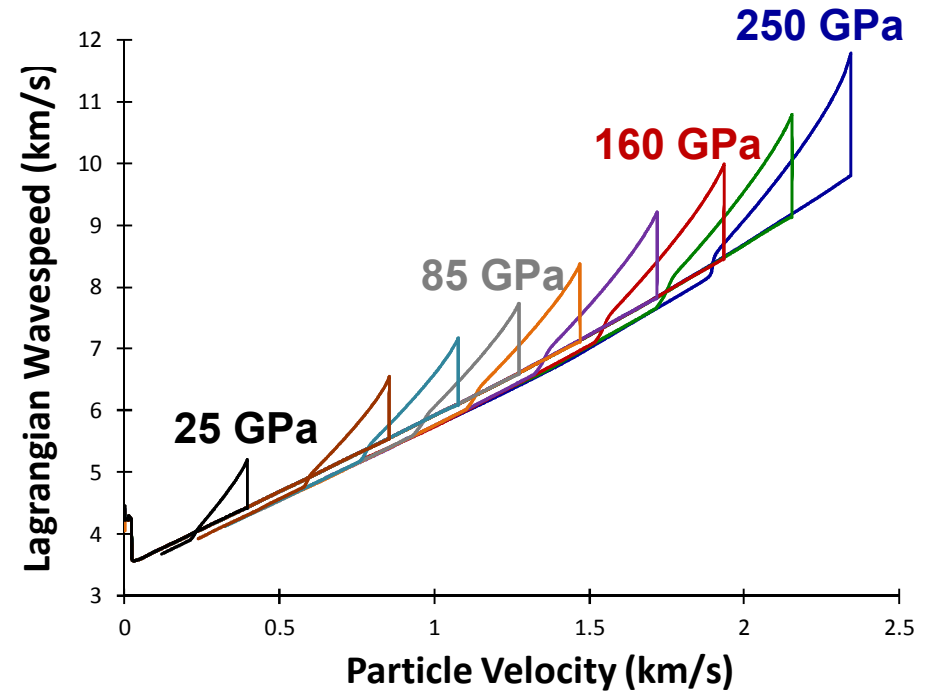
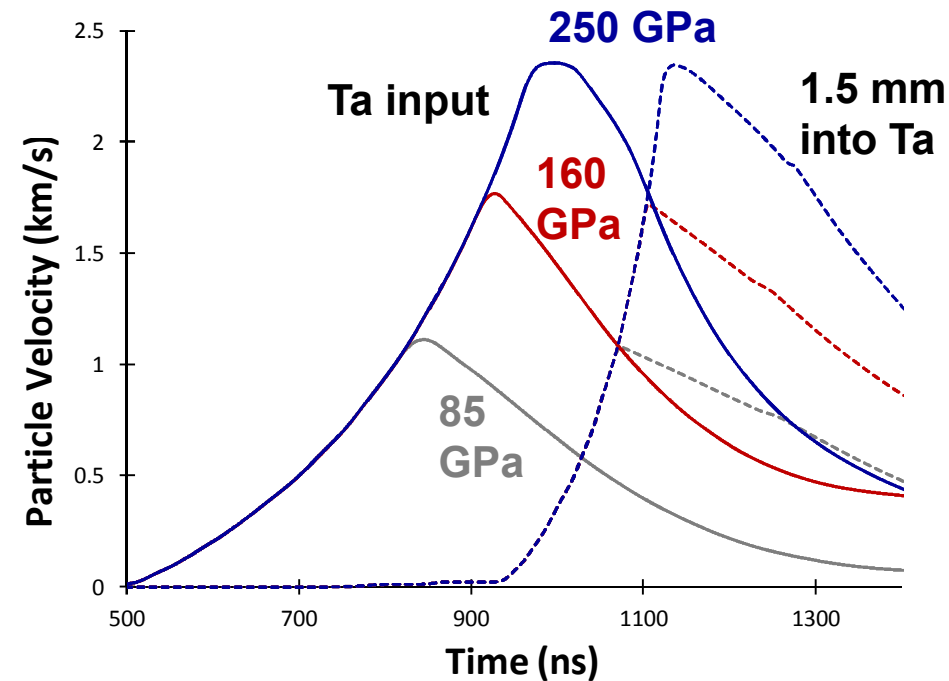
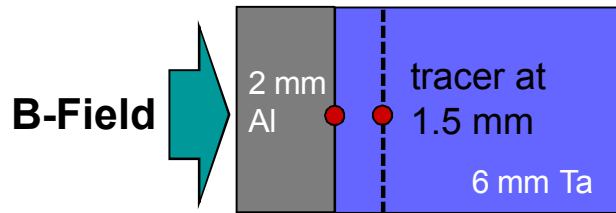
Correction for attenuation

- Attenuation can have a dramatic effect on the strength measurement
 - A correction can be formulated assuming quasi-elasticity is linear near peak
 - Validity of the assumption can be addressed with synthetic data

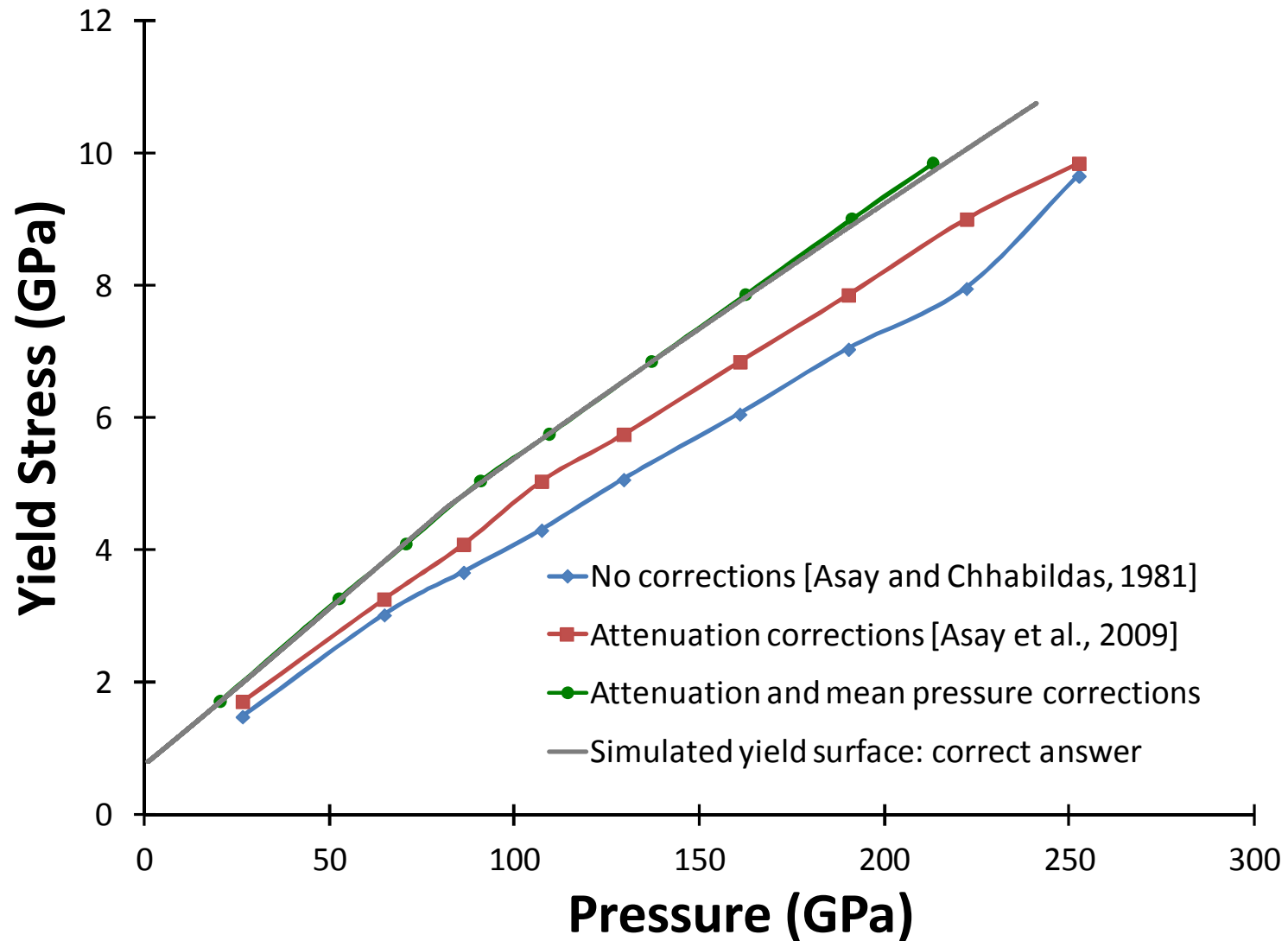


Numerical simulations of tantalum to 2.5 MBar

- EOS: sesame 90210
- Strength: standard SG Ta parameters, except A (pressure hardening) is 3x higher

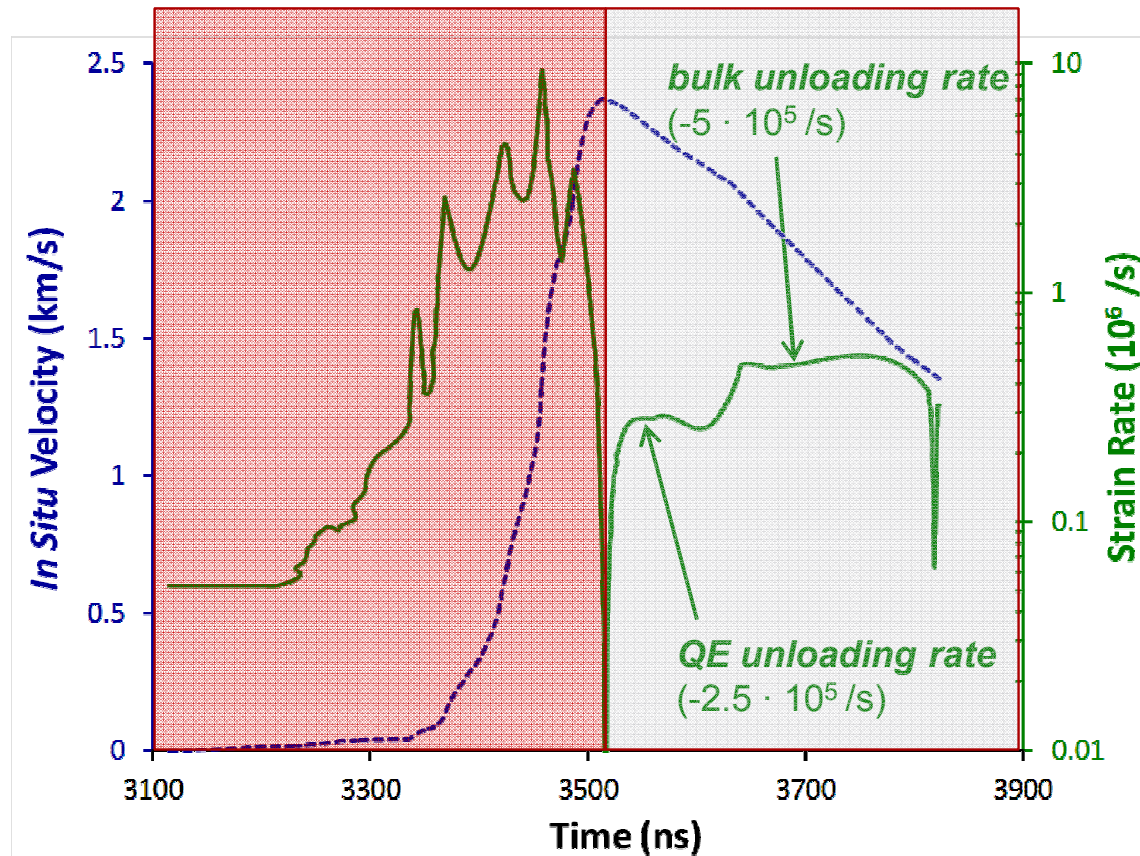


Self-consistent analysis reproduces yield surface with corrections



Strain-rate is relatively constant where the strength is extracted

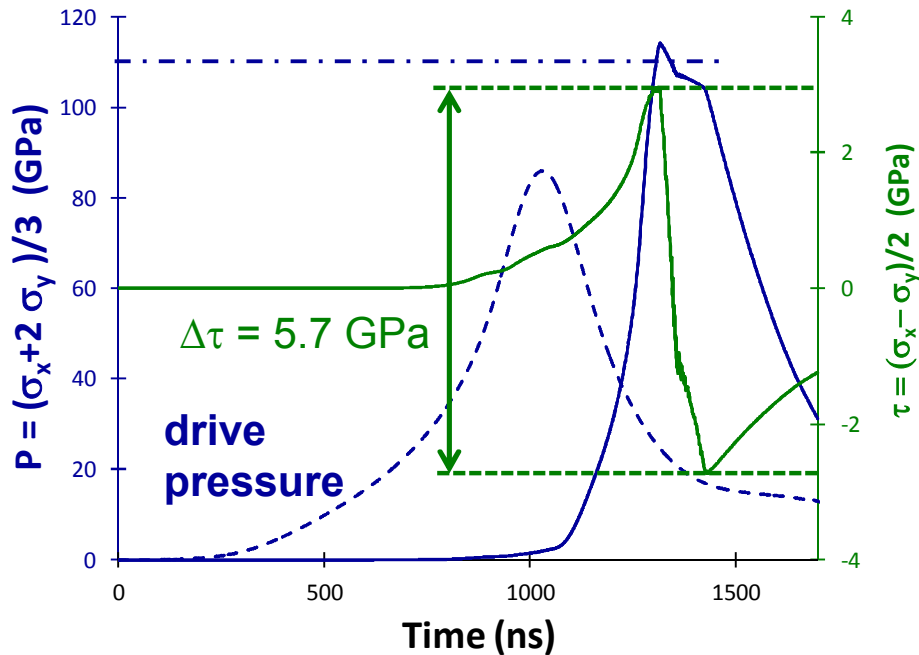
- A typical Z ramp experiment
 - Loading rates: $10^5 - 10^7$ 1/s
 - Unloading rates: $2.5 - 5 \cdot 10^6$ 1/s



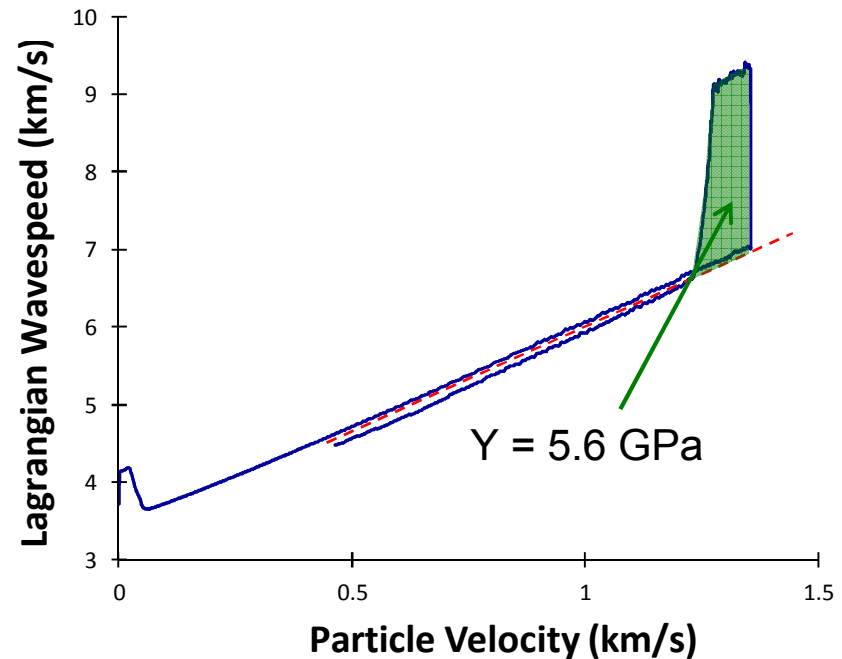
Self-consistent analysis of a rate-dependent simulation still works

- Synthetic analysis of a dislocation based model courtesy J. Ding

Stress tensor analysis

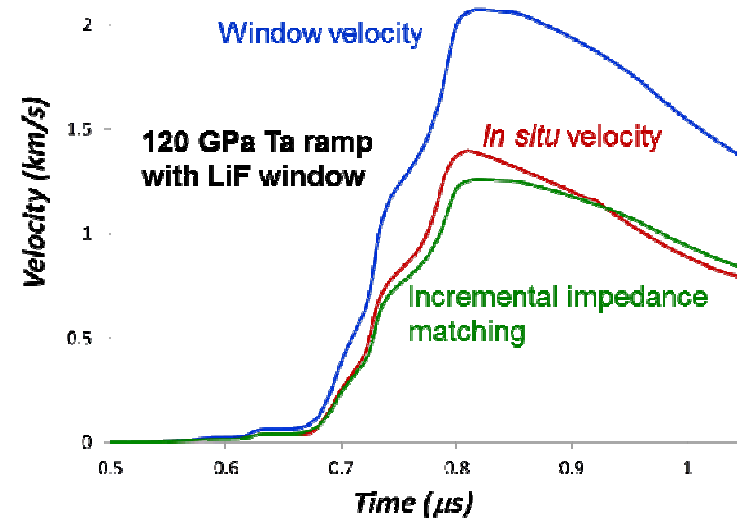
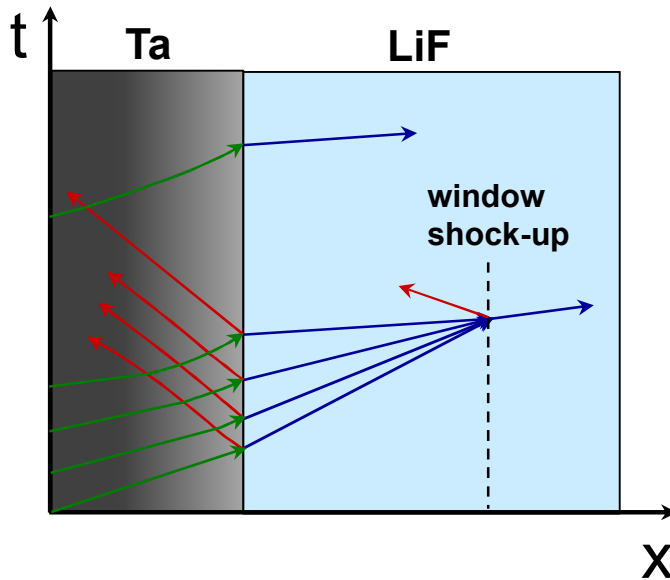
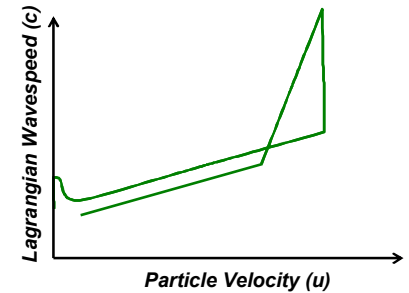


Self-consistent analysis



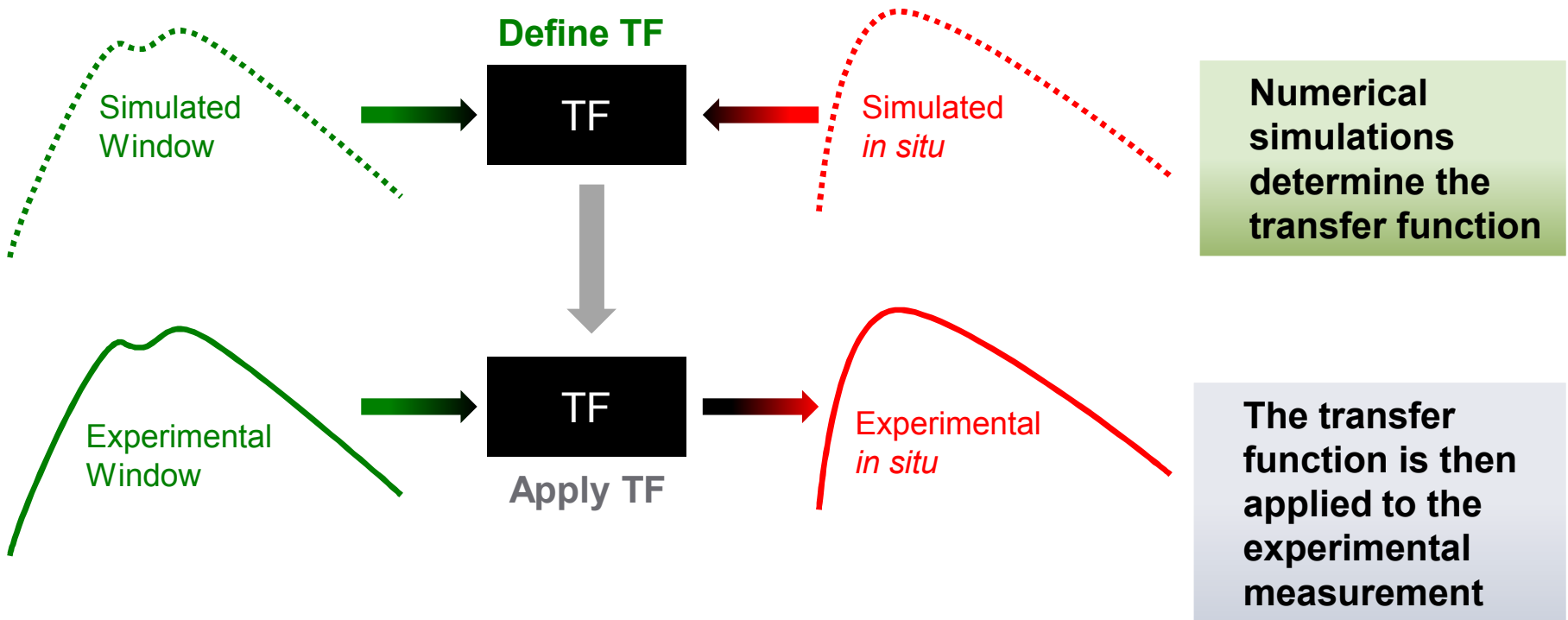
It is critical to properly account for window effects

- A window is necessary to measure a full release into bulk unloading
 - Wave reflection: creates highly non-uniform state in the sample
 - Characteristic bending : changes timing of the measured waveform
- Traditional analysis methods do not work
 - Impedance matching only accounts for impedance mismatch
 - Backwards characteristics requires a 1-1 wavespeed response



Transfer function methodology

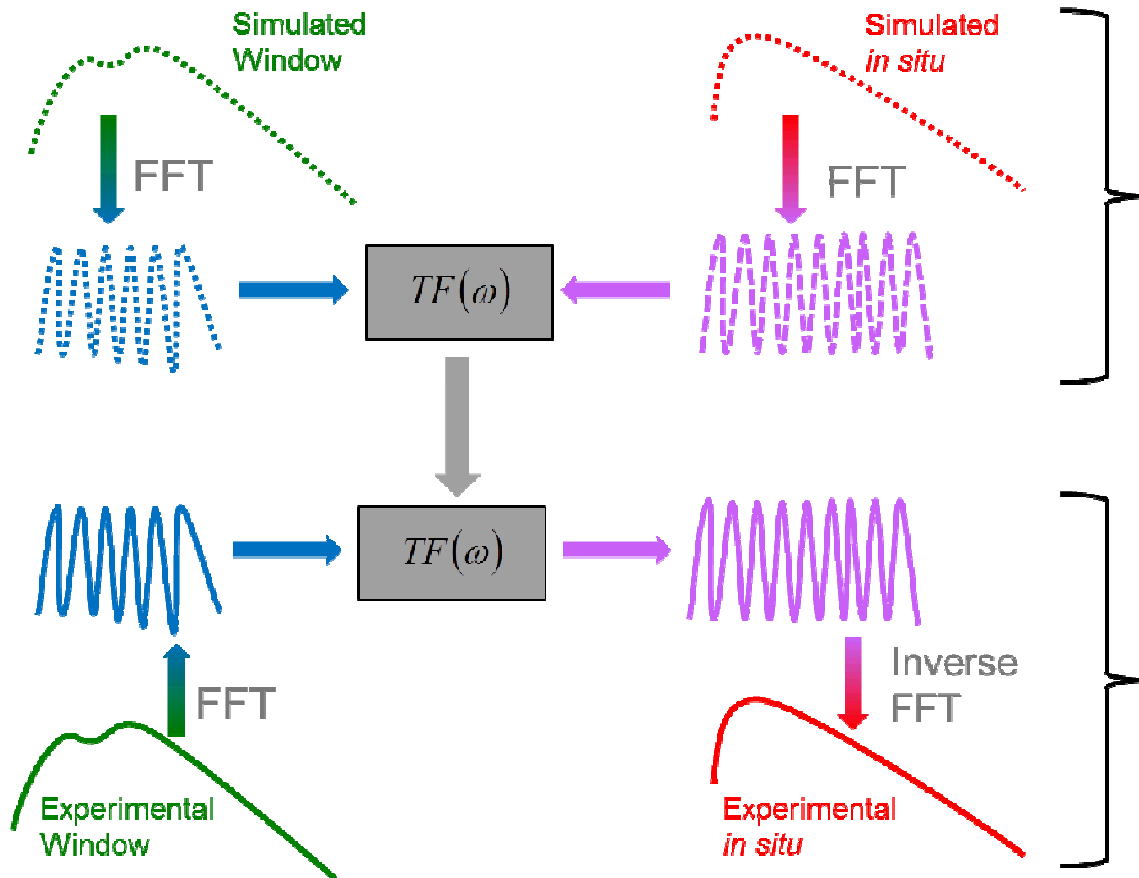
- Use the hydrocode (EOS + Strength) to approximate the wave interactions
 - Determine mapping from *in-situ* to window velocities
- Map these interactions to the actual experiment
 - Map from experimental window to experimental *in situ*



Transfer function defined

- A linear time invariant (LTI) system can be defined by the convolution integral:

$$u_{in\ situ}^{simulated}(\bar{t}) = u_{window}^{simulated}(\bar{t}) * tf(\bar{t}) = \int_{-\infty}^{\infty} u_{window}^{simulated}(\bar{t} - \tau) \cdot tf(\tau) d\tau$$



The transfer function is defined in the frequency domain by the numerical simulations

$$U_{in\ situ}^{simulated}(\omega) = U_{window}^{simulated}(\omega) \cdot TF(\omega)$$

$$TF(\omega) = \frac{U_{in\ situ}^{simulated}(\omega)}{U_{window}^{simulated}(\omega)}$$

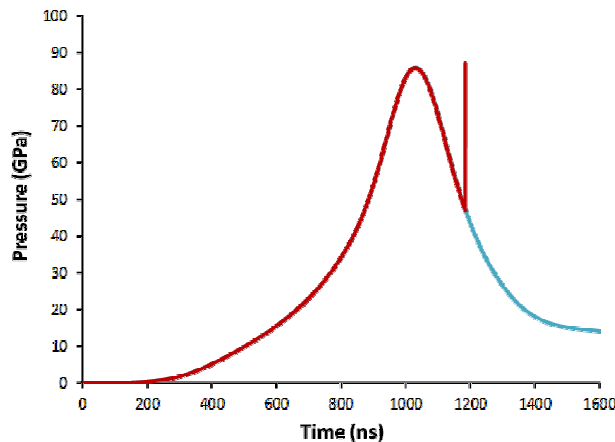
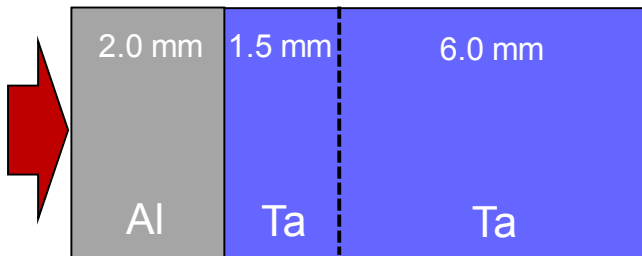
The transfer function is applied to the experimental data

$$U_{in\ situ}^{experimental}(\omega) = U_{window}^{experimental}(\omega) \cdot TF(\omega)$$

Application to the rate-dependent simulation



P(t)



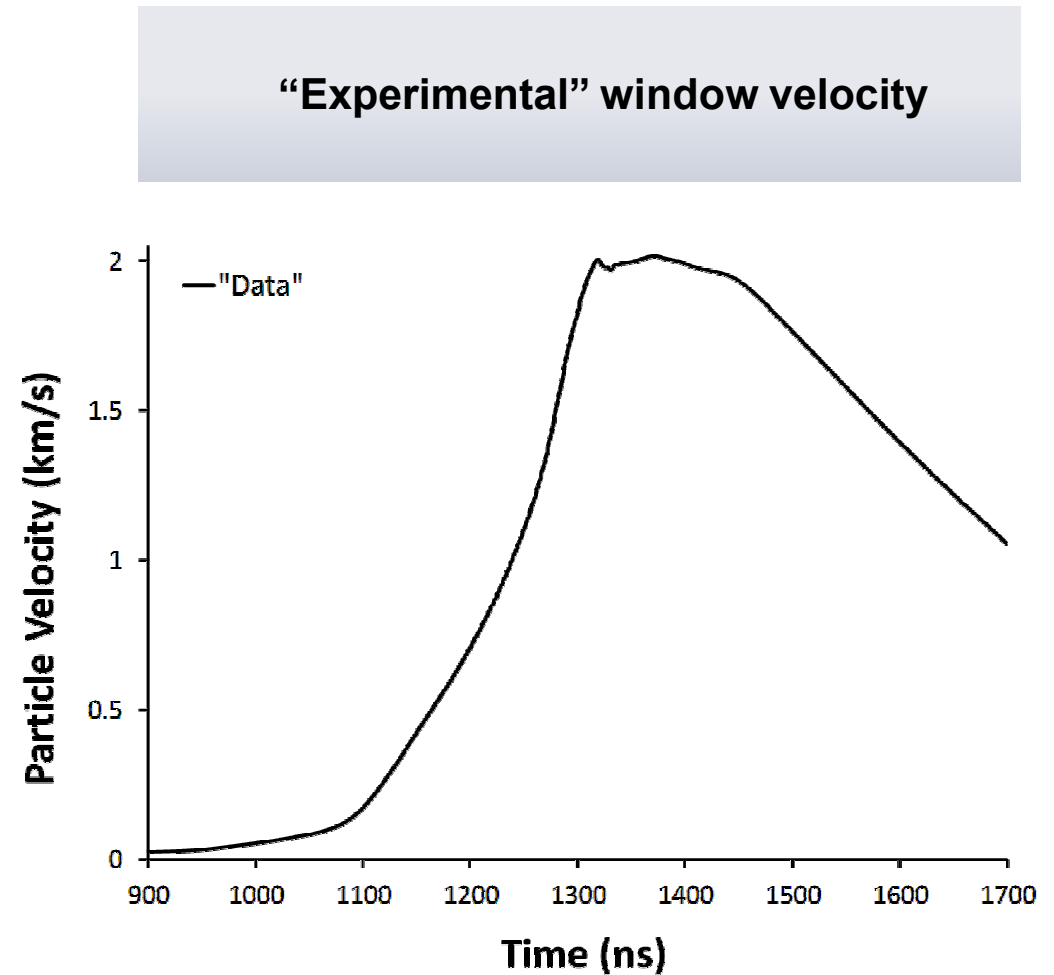
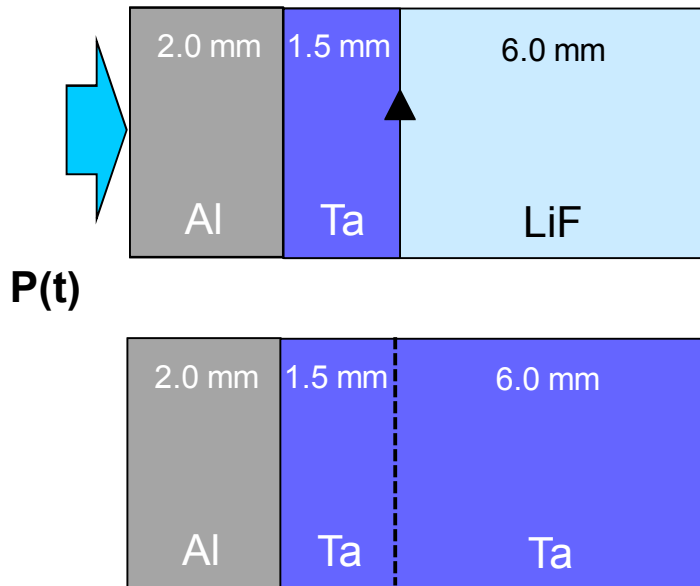
■ “Experimental Data” models

- Mie-Grüneisen EOS
- Strength:
 - Al : hydrodynamic
 - Ta: dislocation mechanics
 - LiF: elastic perfectly plastic

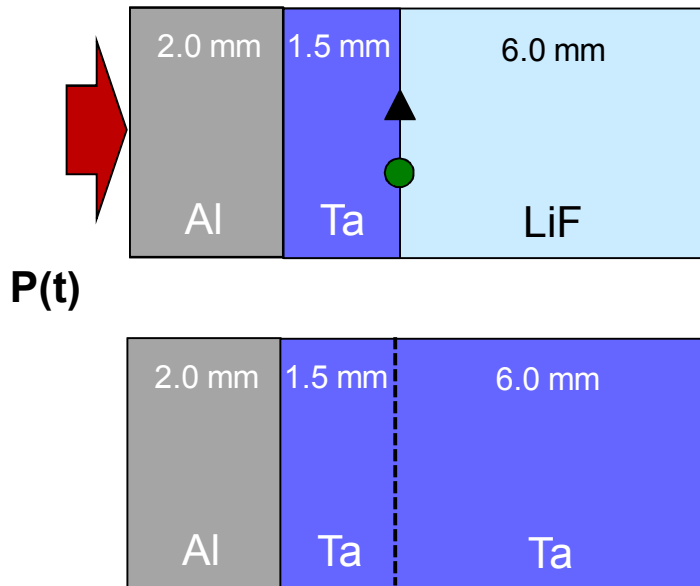
■ Simulation models

- SESAME tabular EOS
 - Al3700, Ta90210, LiF7271
- SG QE strength

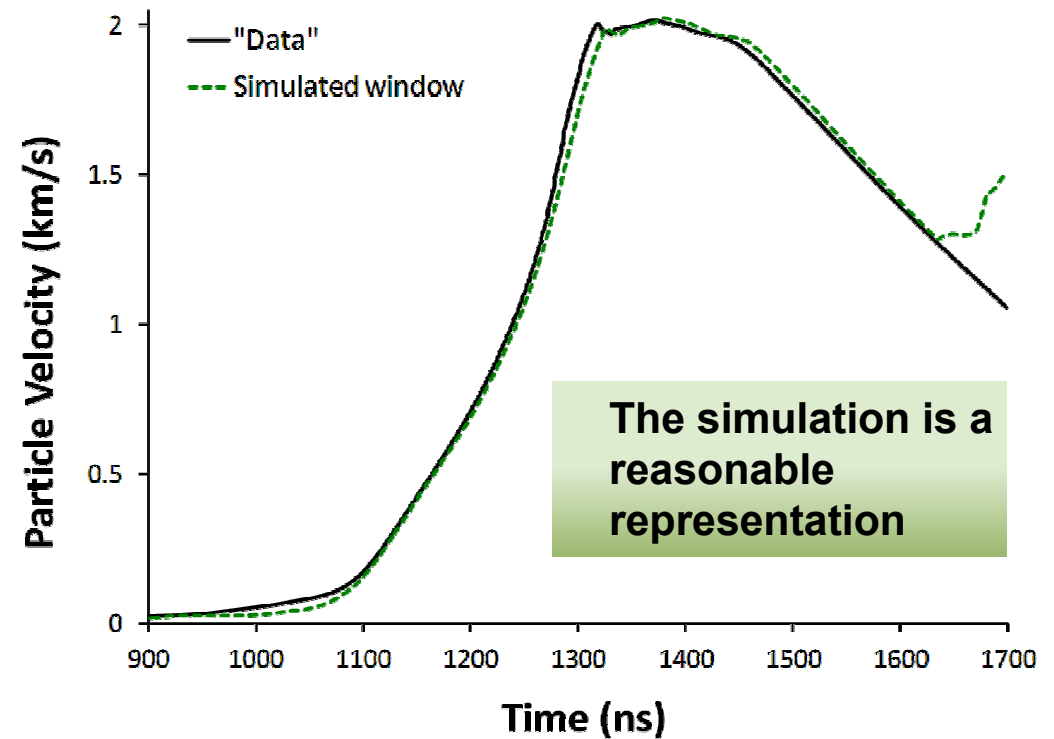
Application to the rate-dependent simulation



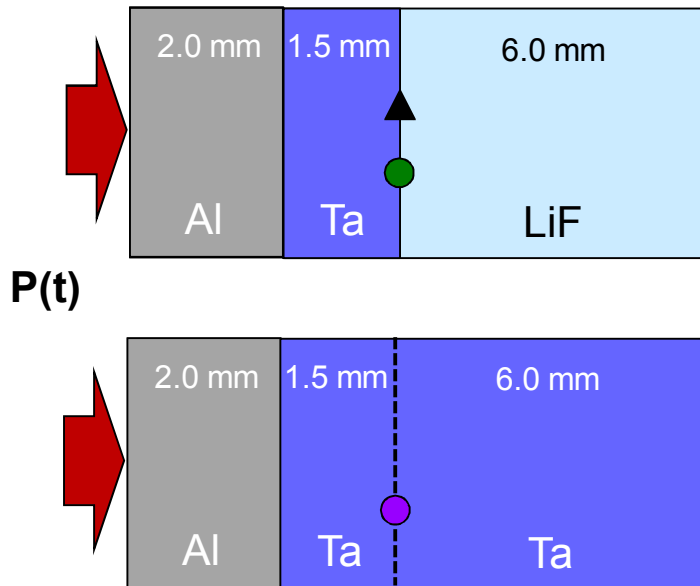
Application to the rate-dependent simulation



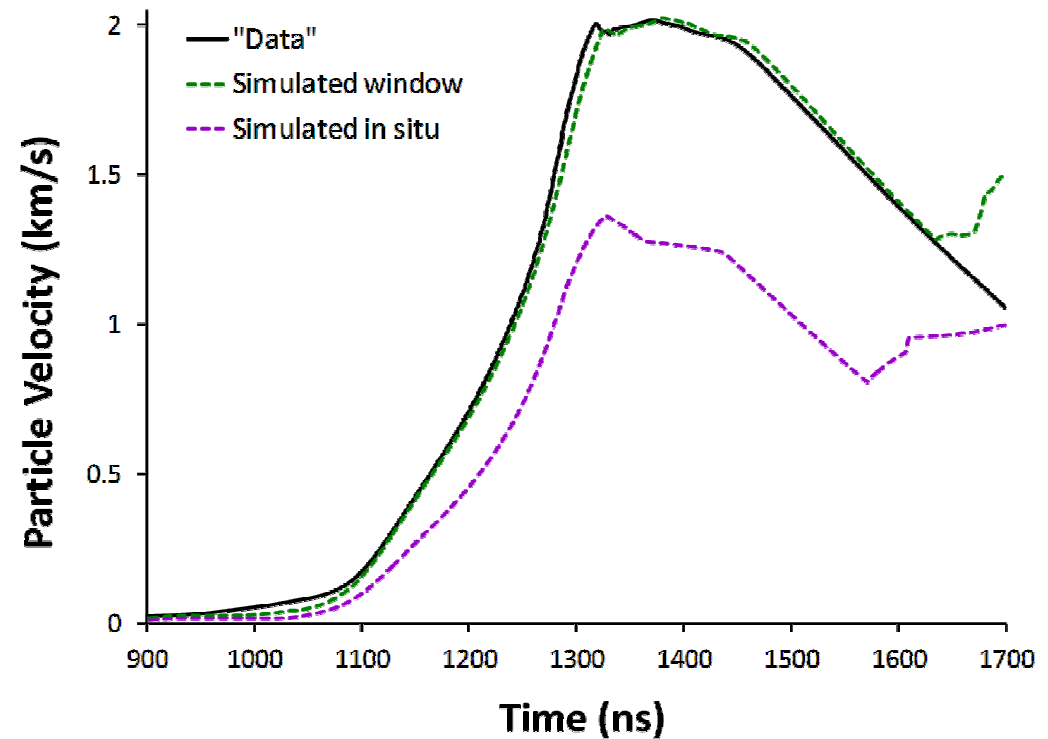
A forward simulation of the experiment is performed



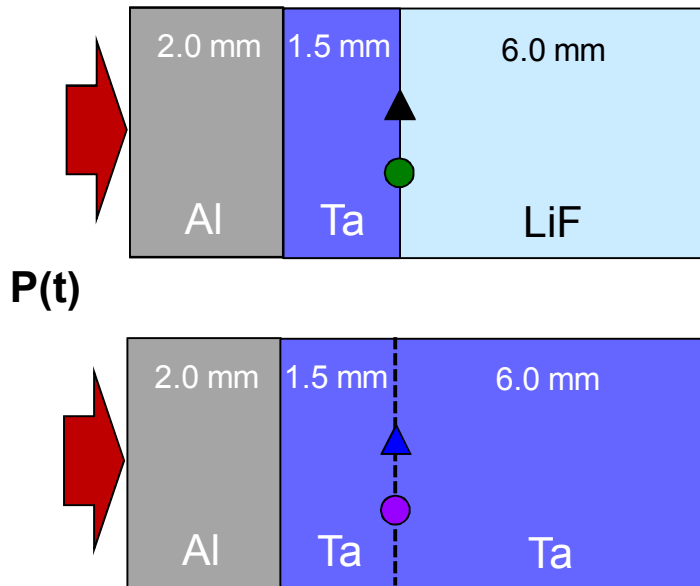
Application to the rate-dependent simulation



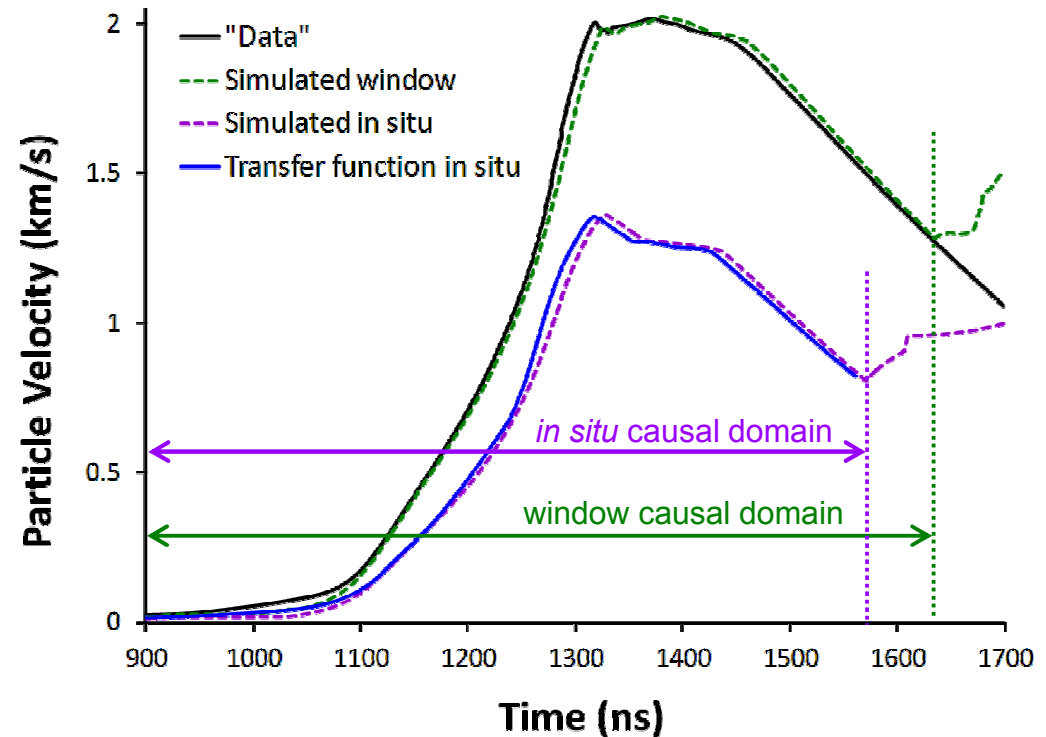
The corresponding *in situ* forward simulation



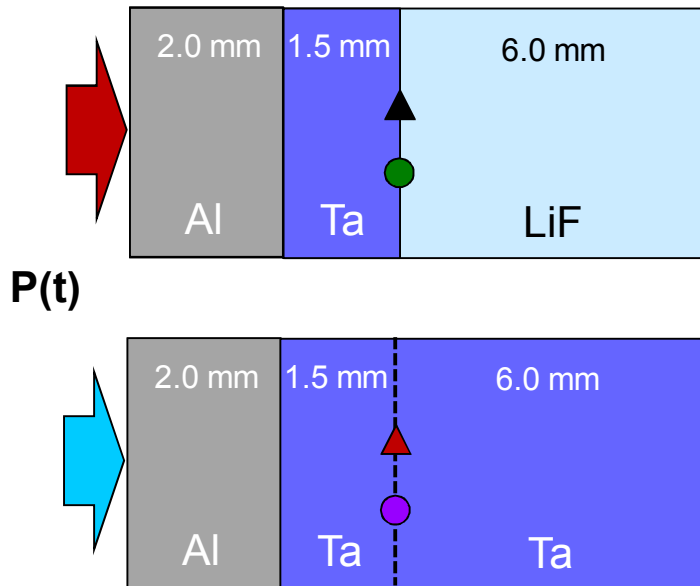
Application to the rate-dependent simulation



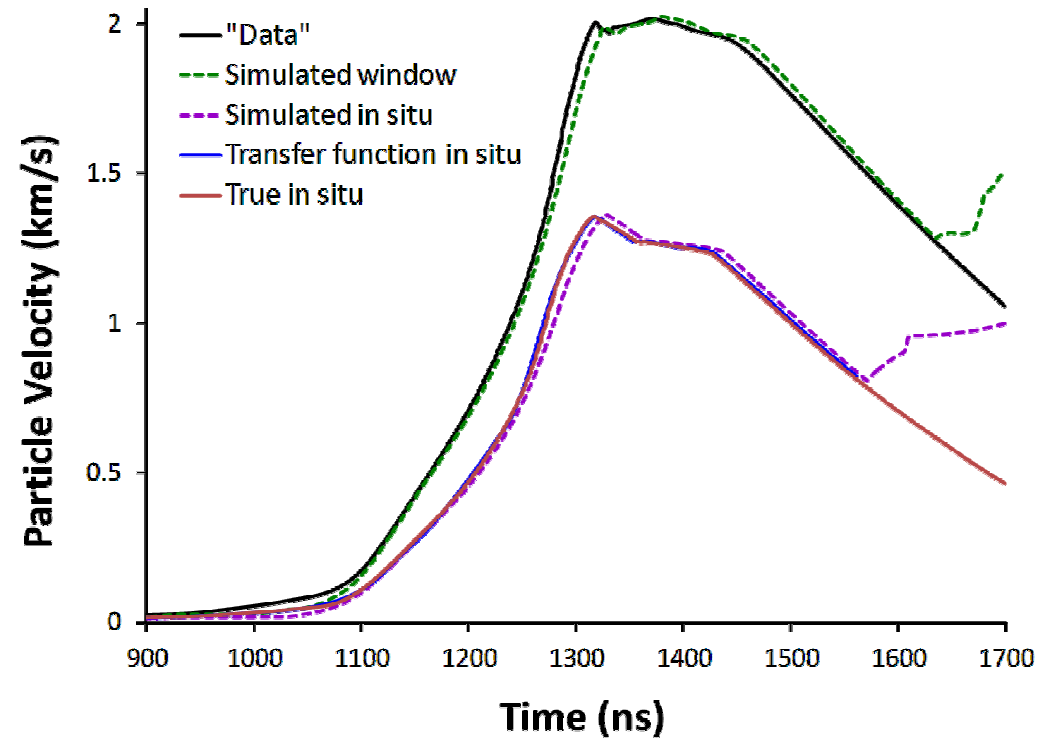
Apply the transfer function to the "data" to determine the experimental *in situ* response



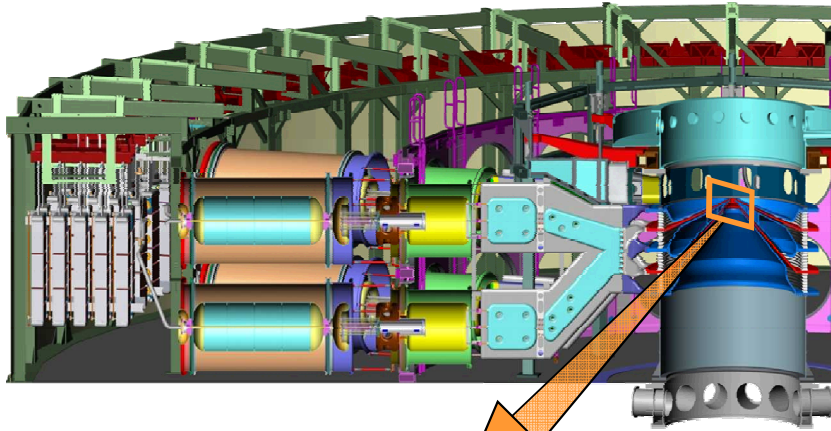
Application to the rate-dependent simulation



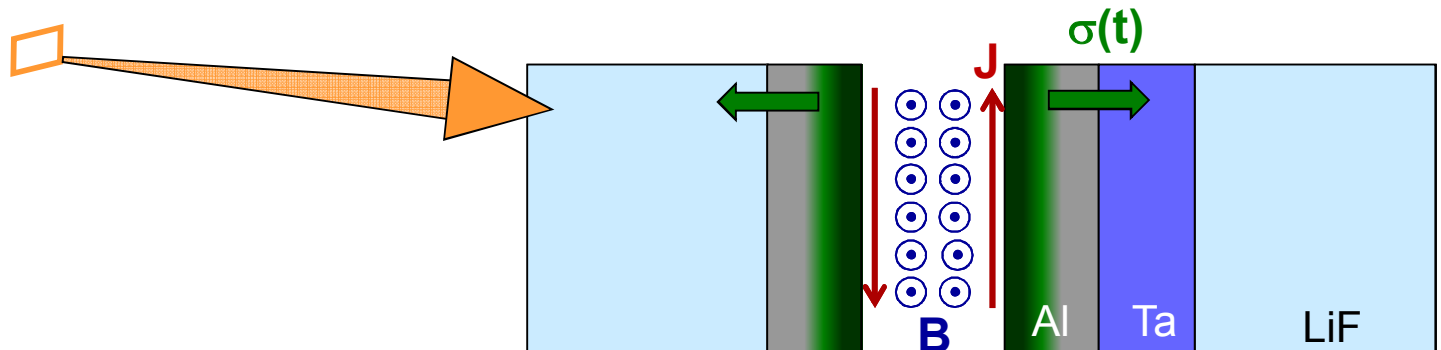
Despite significant differences in the models, the TF reproduces the correct *in situ* response!



The Sandia Z machine

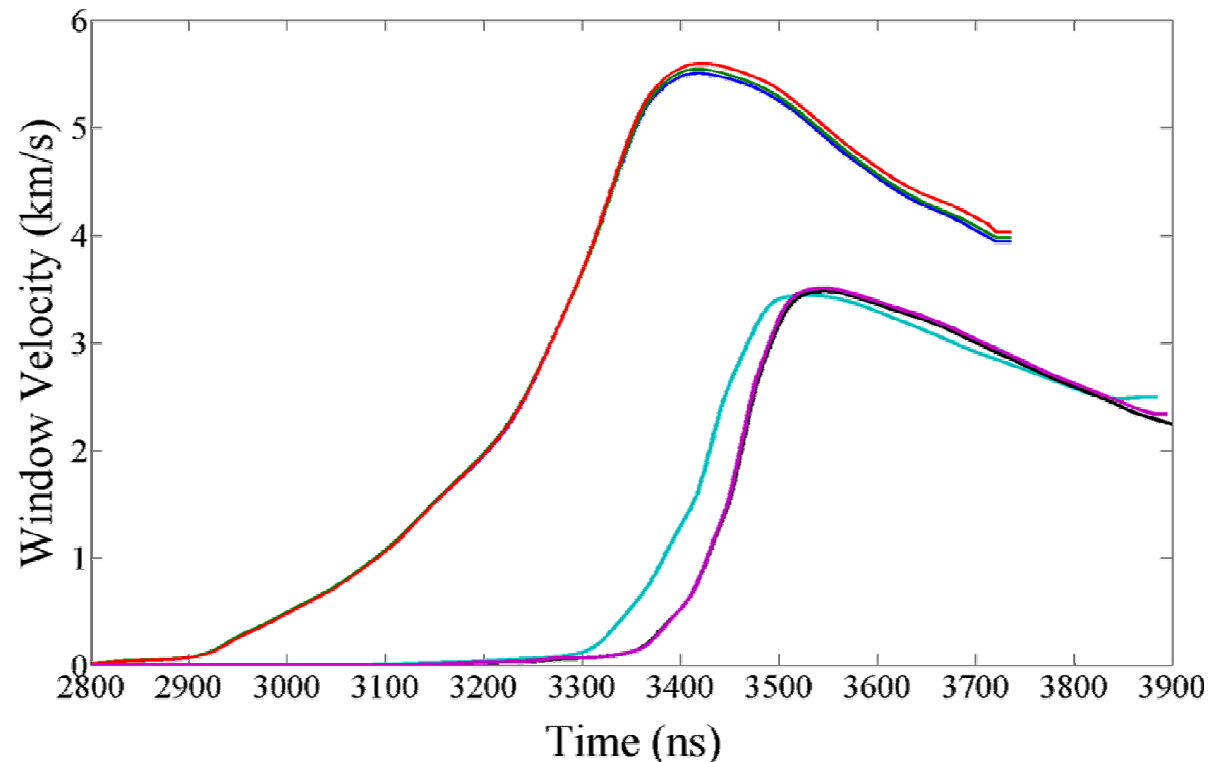
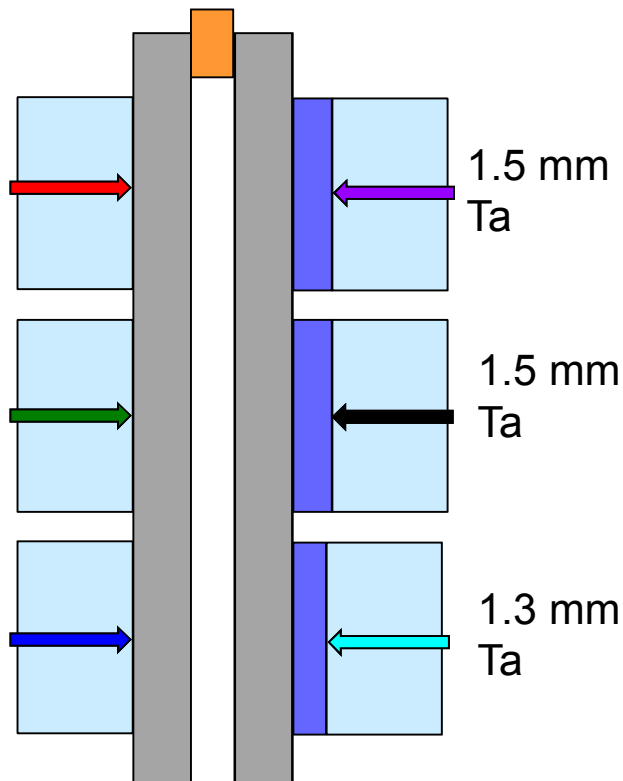


- Current pulse of up to 26 MA delivered to parallel flat-plate electrodes shorted at one end
- Magnetic ($J \times B$) force induces ramped stress wave in electrode material
- Stress wave propagates into ambient material, de-coupled from magnetic drive
- Controllable pulse shape, rise time 100 – 1200 ns
- Identical magnetic loading of sample pairs

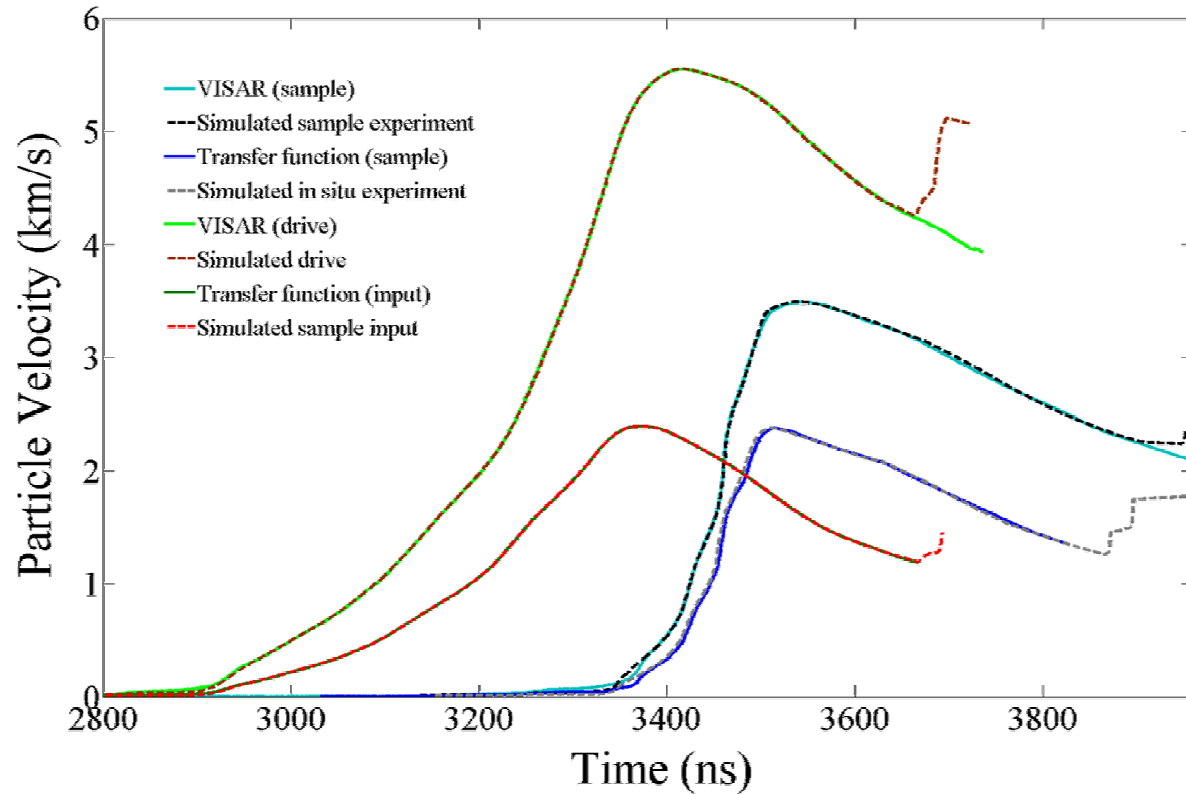
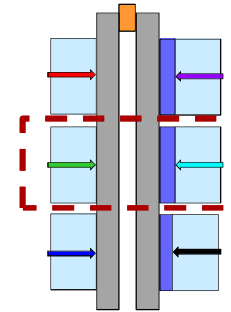
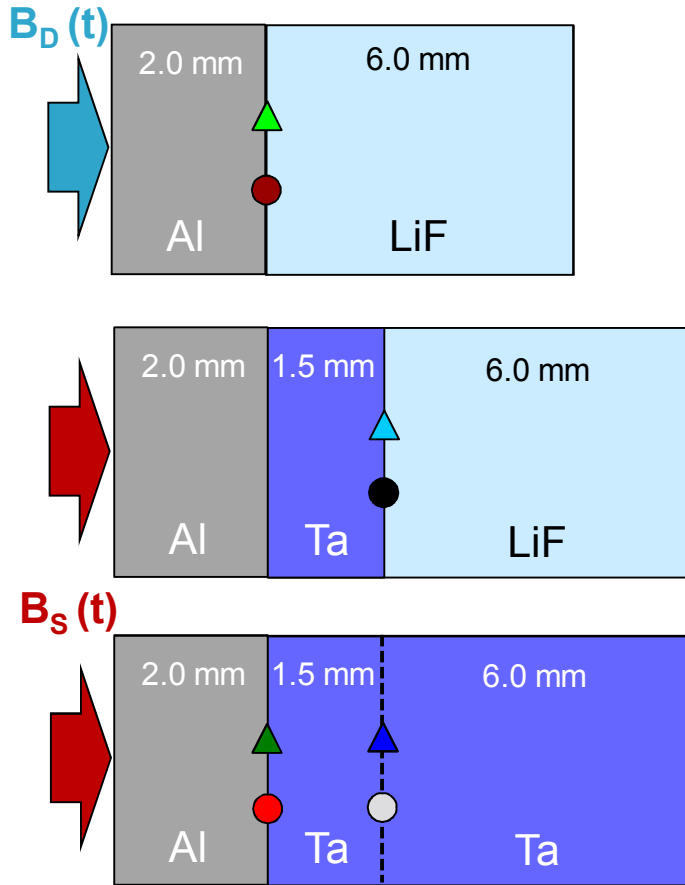


A typical experiment: Ta to 2.5 MBar

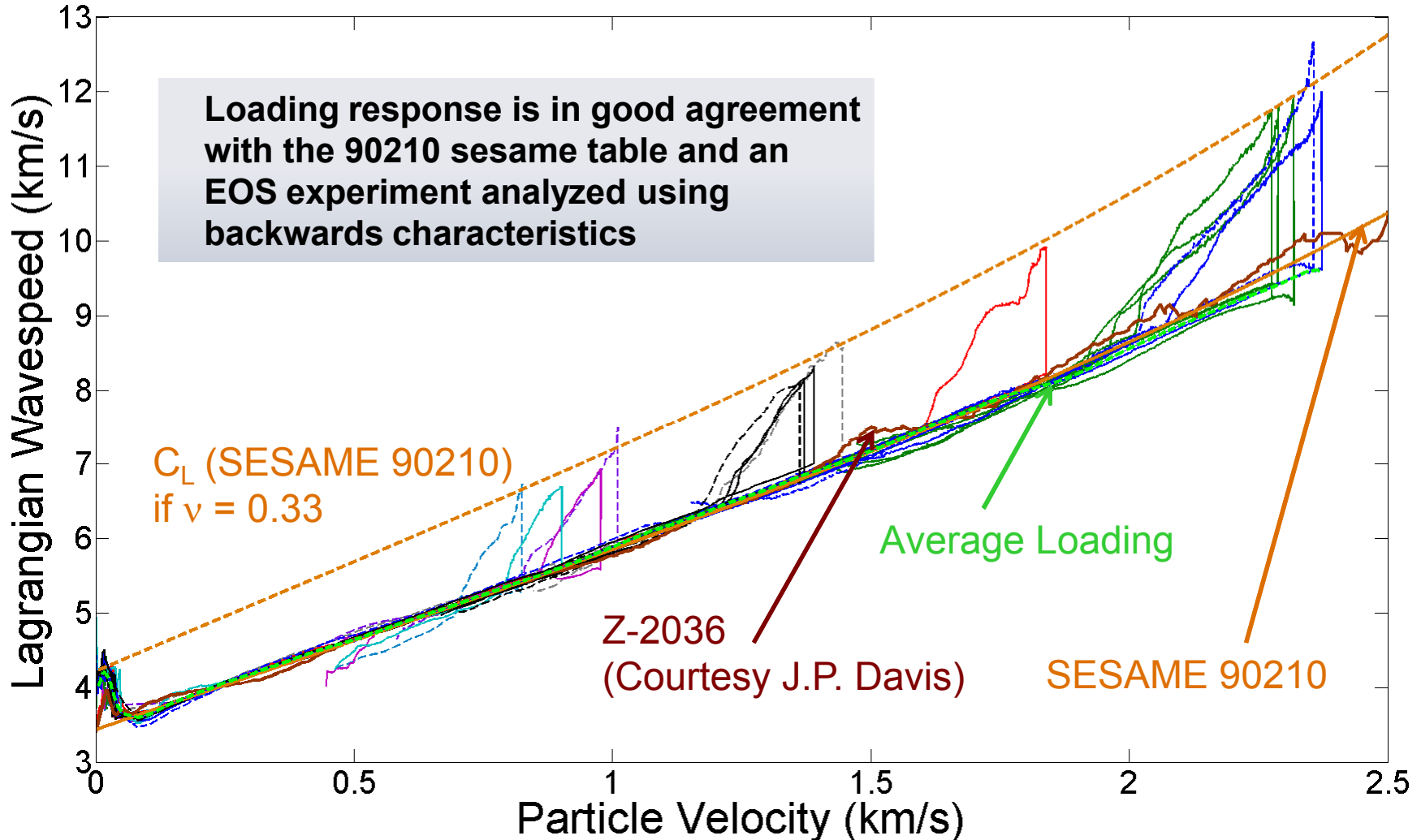
- 15 mm tapered stripline, 1mm AK gap
 - 12 mm diameter samples/windows
 - 2 mm aluminum electrode floor thickness



In situ profiles are determined from the transfer function



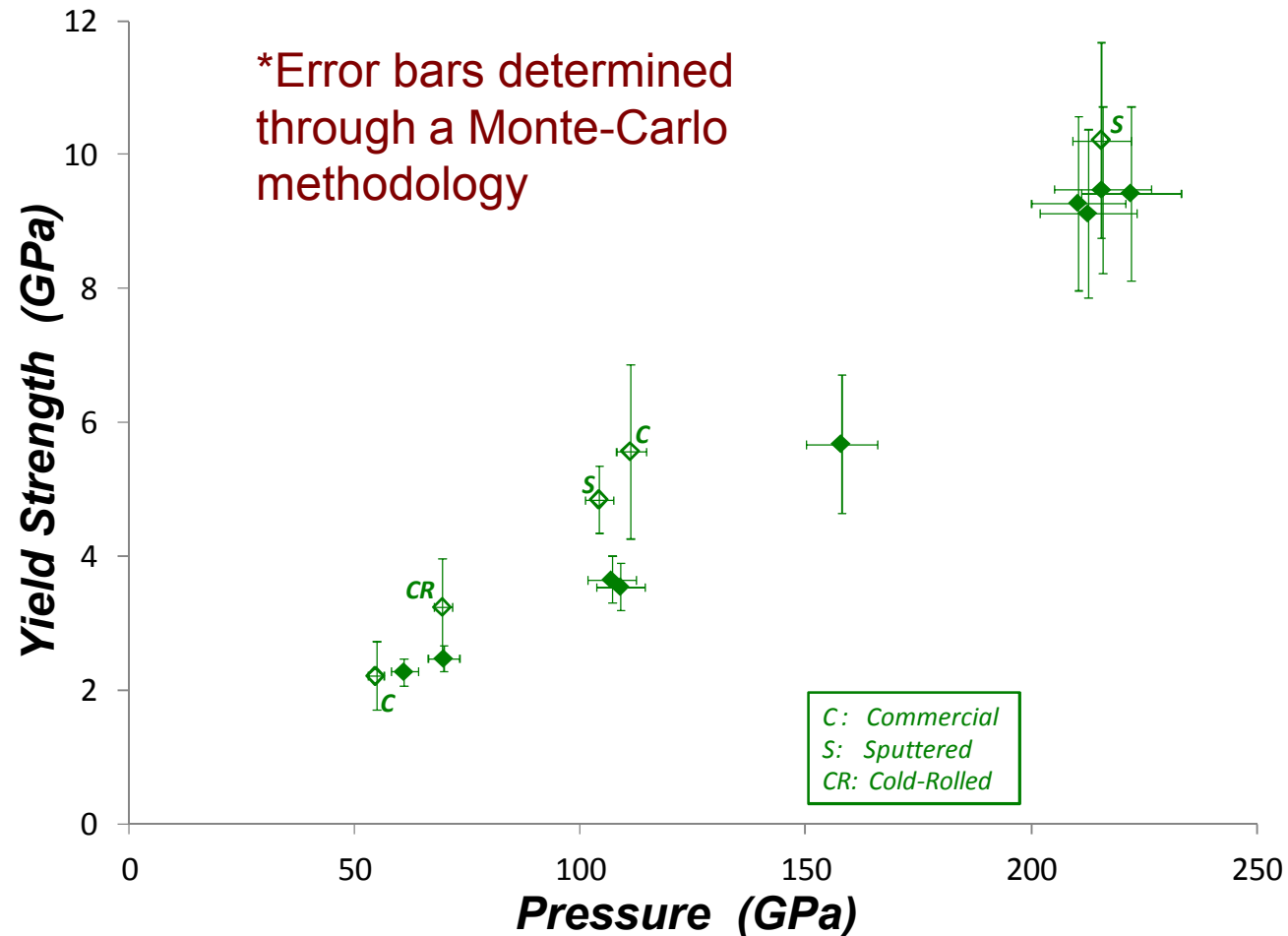
Wavespeed profiles for all of the Ta experiments



Ta strength data obtained on Z

- See an effect of material processing

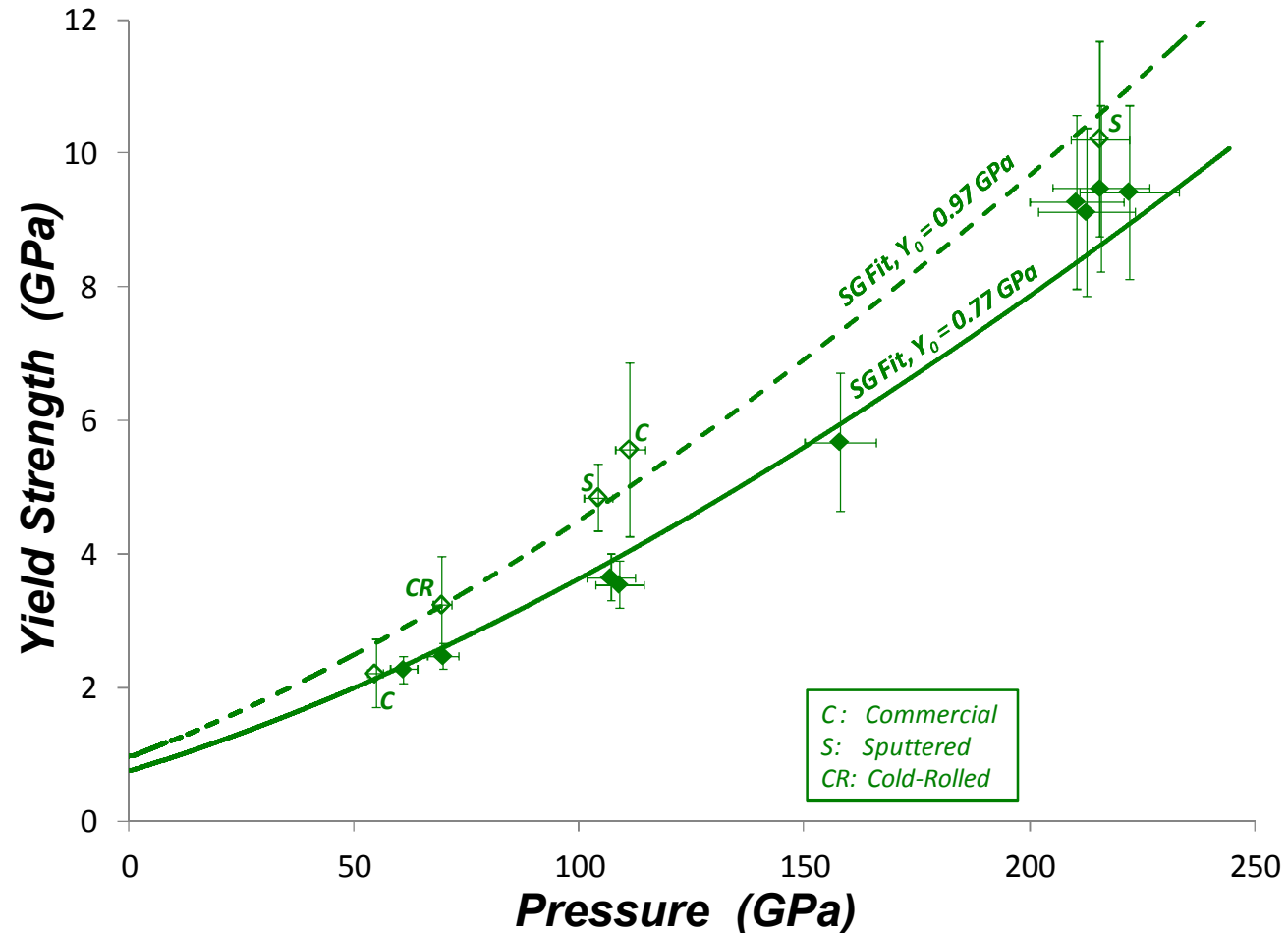
- ◆ New Z results (NNSA) ramp/release $10^5/s$
- ◇ New Z results (other) ramp/release $10^5/s$



Ta strength data obtained on Z

- See an effect of material processing

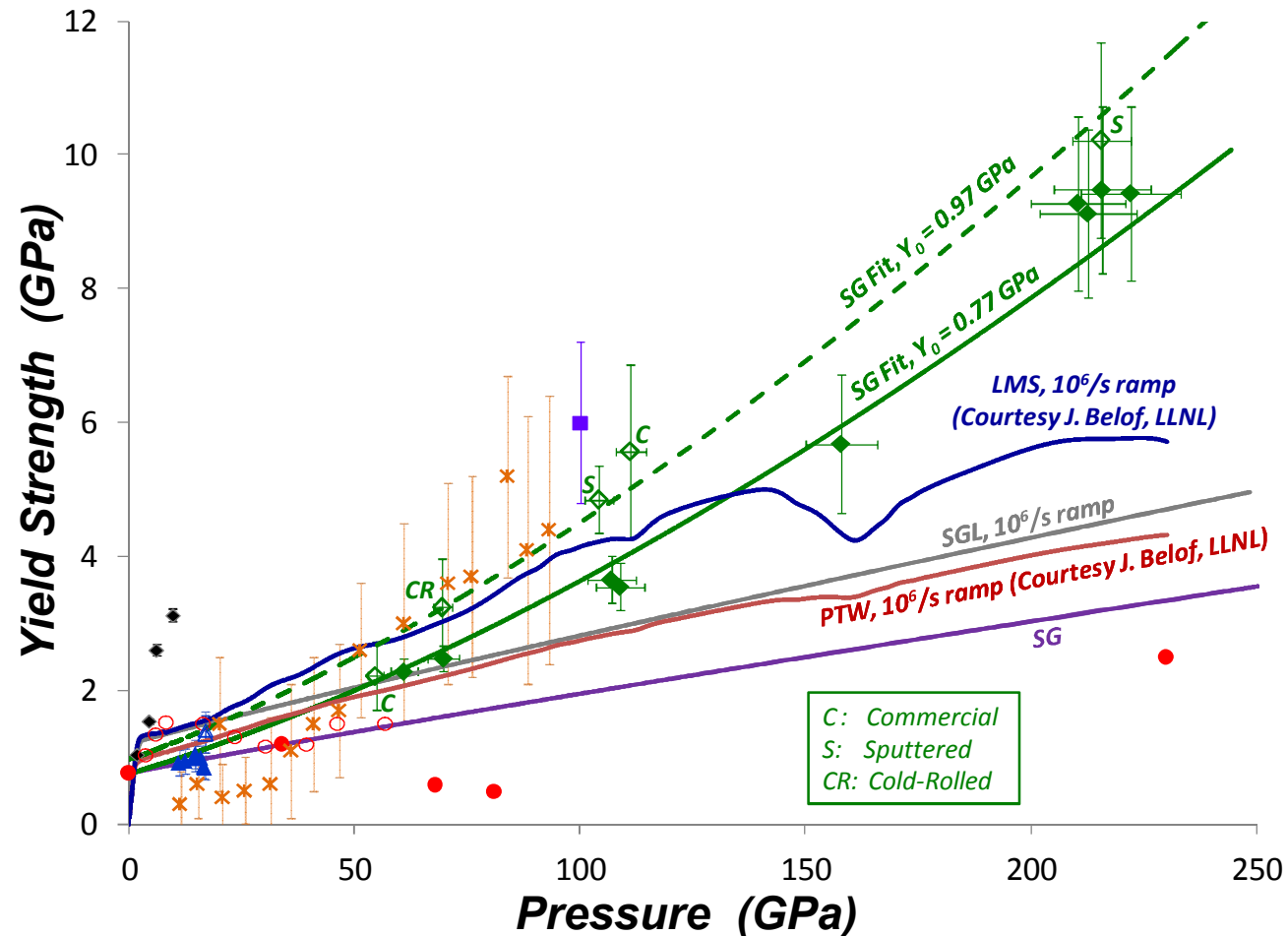
- ◆ New Z results (NNSA) ramp/release $10^5/s$
- ◇ New Z results (other) ramp/release $10^5/s$



Ta strength : a compilation of data

- In good agreement with RT data / LLNL multiscale model
- Ta is significantly stronger than previously believed: factor of 2 at $P > 2$ MBar

- ◆ New Z results (NNSA) ramp/release $10^5/s$
- ◇ New Z results (other) ramp/release $10^5/s$
- ▲ Asay et al., 2009 (annealed) ramp/release $10^5/s$
- △ Asay et al., 2009 (cold-rolled) ramp/release $10^5/s$
- Park et al., 2012 (cold-roll/sputter) Rayleigh-Taylor ramp $10^7/s$
- * Dewaele et al., 2005 (powder) DAC diffraction
- Chhabildas et al., 1990 shock release/reload
- ◆ Gray et al., 2003 shock stress gauges



Results and Conclusions

- Self-consistent method produces low systematic errors
 - Strain rates are approximately constant over unloading
 - Corrections: window (transfer function), mean pressure, attenuation
- Strength experiments to MBar stress levels on Z have been performed on Ta
 - See an effect of material processing
 - Tantalum is much stronger than previously believed

Backups

Why is strength important?

- Deviatoric stresses are important

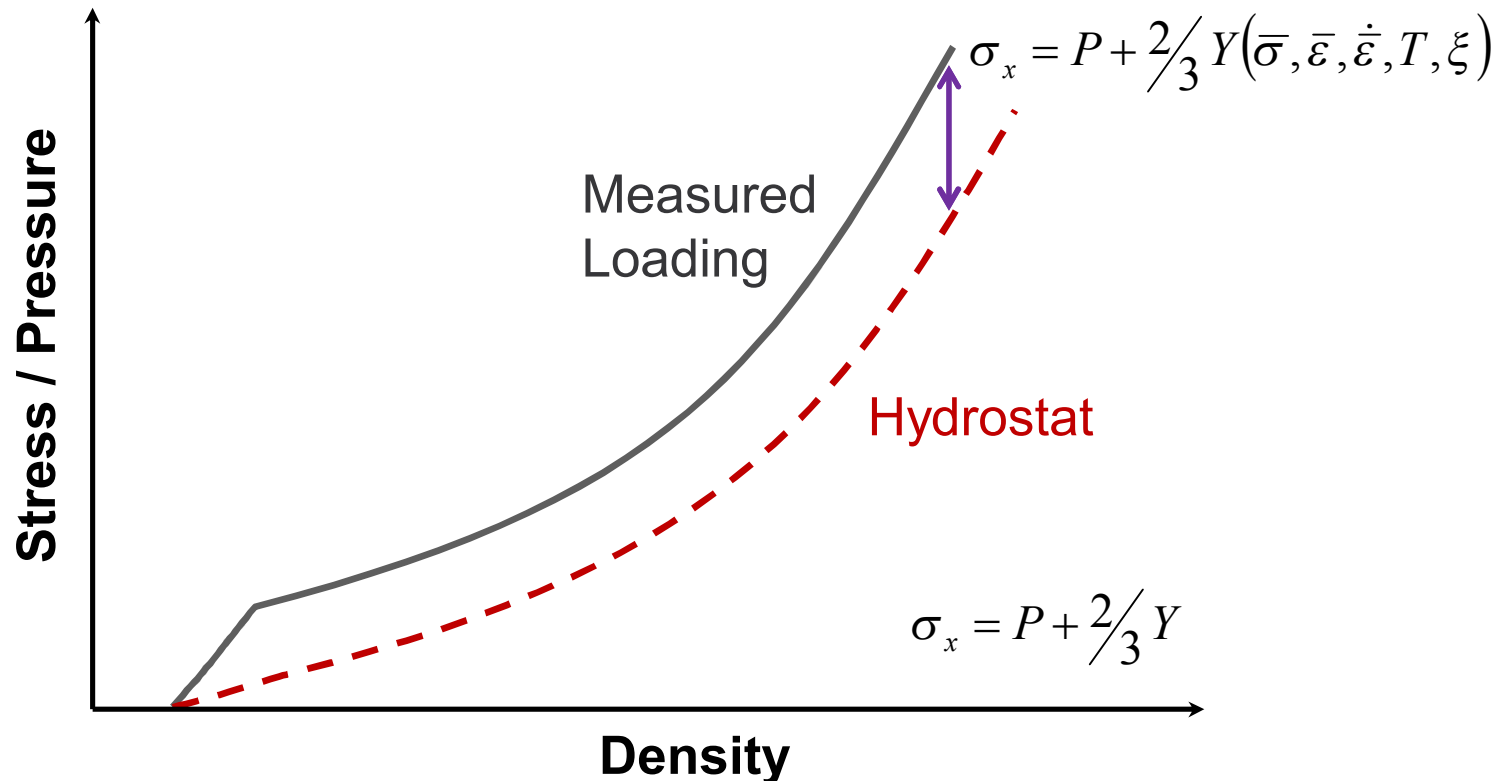
- Lots of interesting physics: dislocations

- EOS: We measure σ_x not P!

Tantalum Example

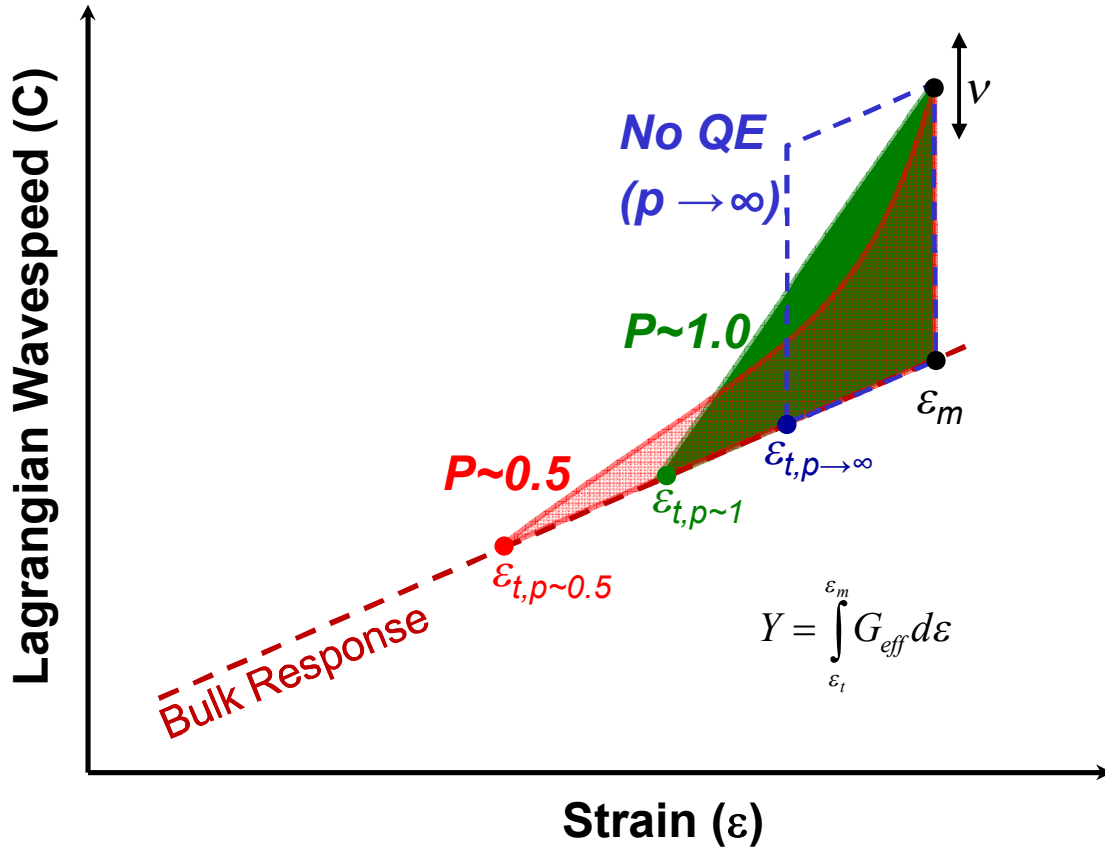
Y = 5 GPa at P = 100 GPa

→ 3% effect



A quasi-elastic strength model

- Steinberg-Guinan yield surface:
$$Y = Y_0 [1 + \beta(\varepsilon + \varepsilon_i)]^n \left[1 + A \frac{P}{\eta^{1/3}} + B(T - 300) \right]$$



Calculate a shear modulus:

$$G = G_0 \left[1 + A \frac{P}{\eta^{1/3}} + B(T - 300) \right]$$

OR

$$G = \frac{3K(1 - 2\nu)}{2(1 + \nu)}$$

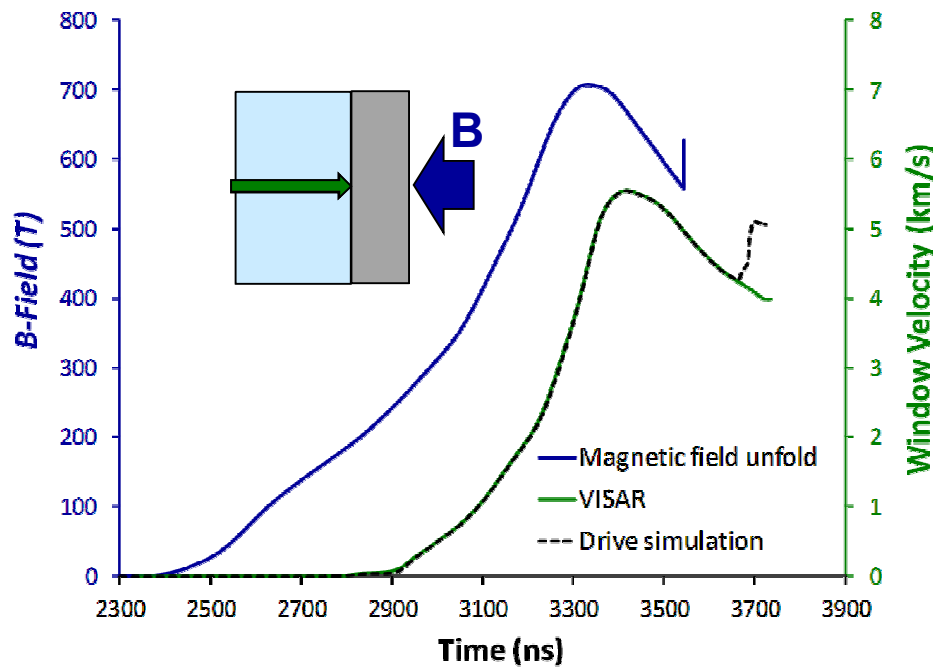
Determine an effective G over unloading and a transition strain consistent with Y:

$$G_{eff} = G \left(1 - \frac{\varepsilon_m - \varepsilon}{\varepsilon_m - \varepsilon_t} \right)^p$$

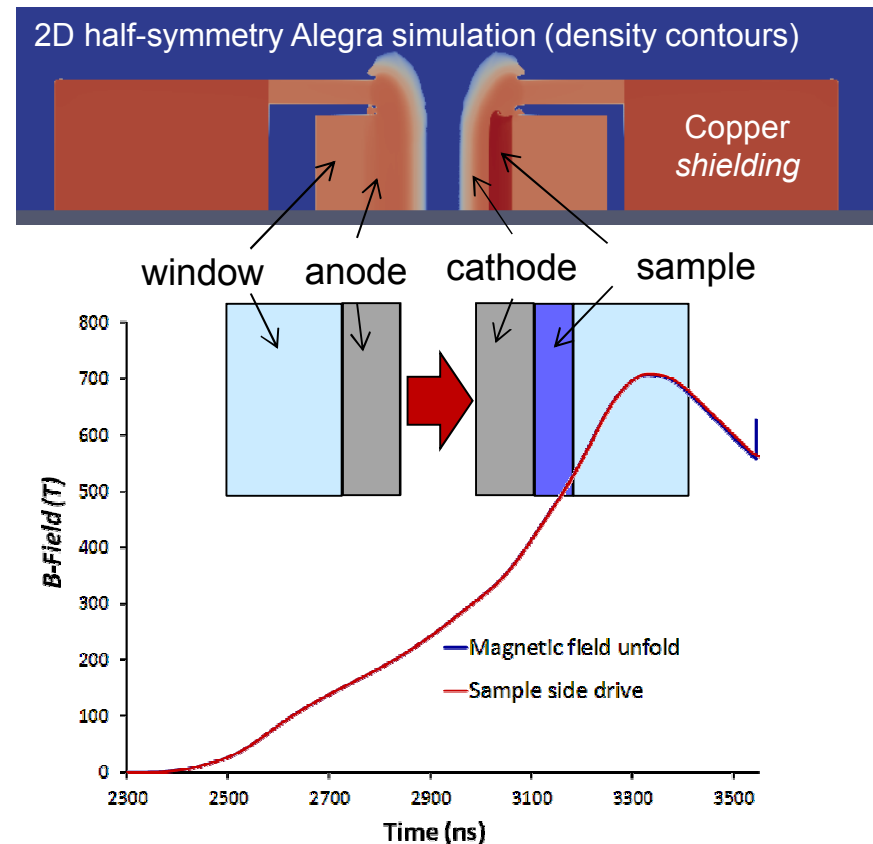
$$\varepsilon_t = \varepsilon_m - \frac{Y}{G} \left(\frac{p+1}{p} \right)$$

Determination of sample side B-Field

- 1-D “unfold” of drive B-Field
 - MHD hydrocode coupled with Dakota optimization package
 - Sesame 3700 + LMD

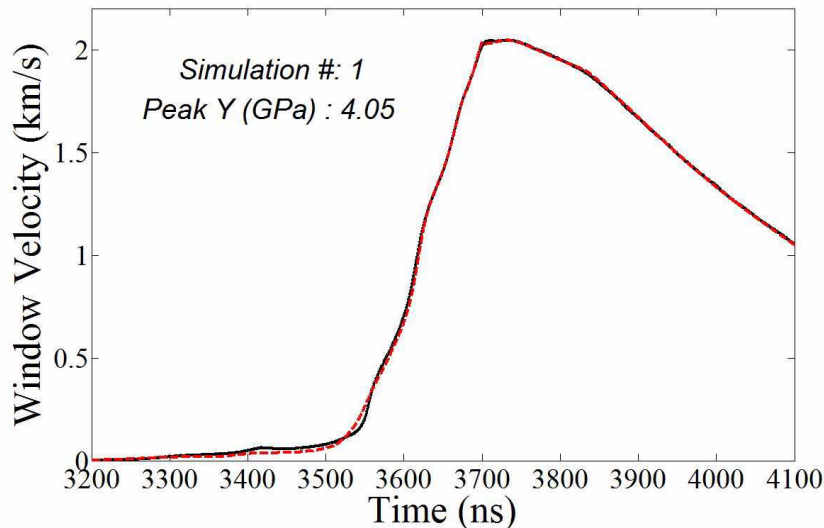


- 2D current driven simulations determine sample side B-Field



Monte-Carlo UQ methodology

- Allow experimental uncertainties and model parameters to vary by Monte-Carlo statistics
 - Automate the analysis for each statistical variation
 - Run window and *in situ* simulations
 - Apply the transfer function
 - Perform Lagrangian analysis
 - Calculate strength including attenuation and pressure corrections



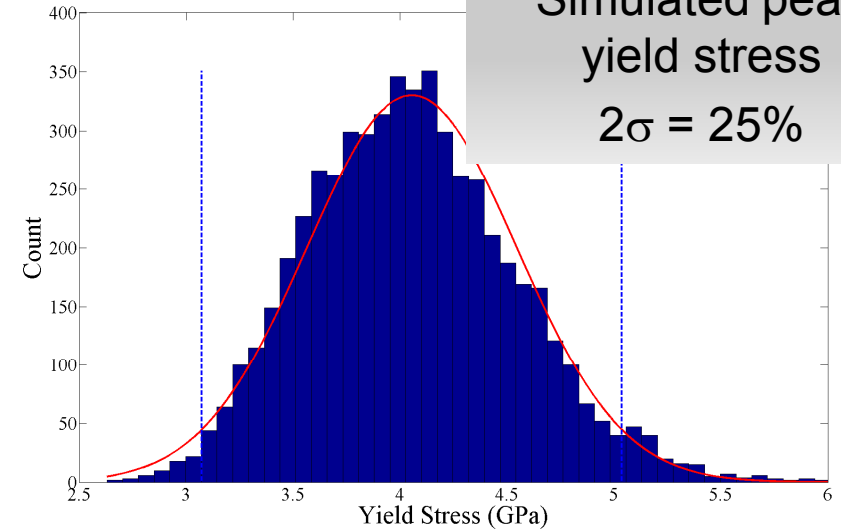
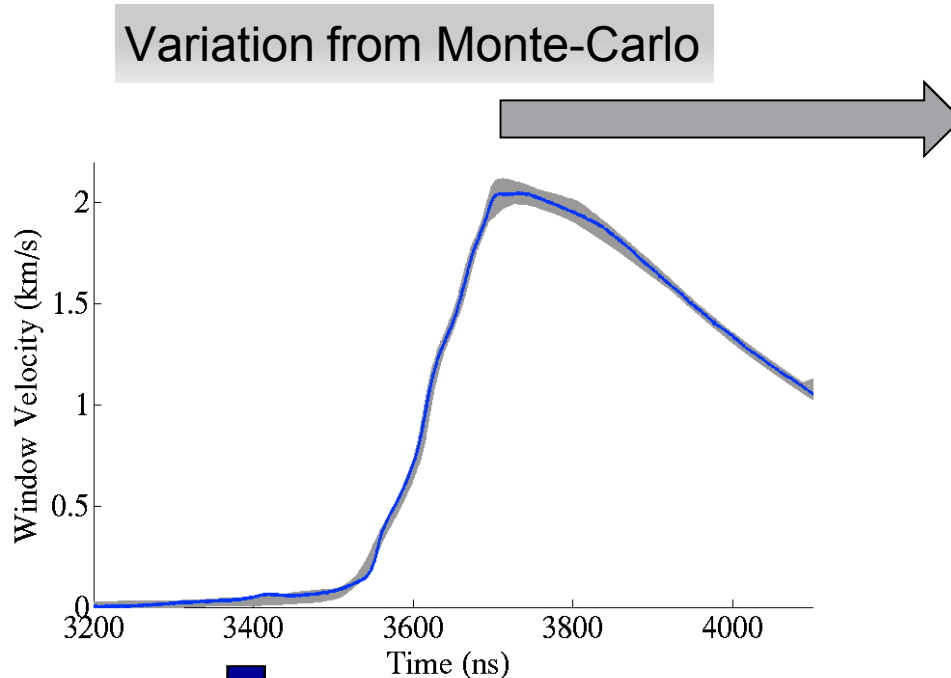
- Experimental variance
 - Thickness : $\pm 3 \mu\text{m}$
 - Relative timing: $\pm 1 \text{ ns}$
 - VISAR uncertainty: 0.2 %

- Model variance
 - Y_0 : 5%
 - β, n, A : 20%
 - ρ_0, B : 2%
 - v : 0.3 ± 0.1
 - p : 1.0 ± 0.5

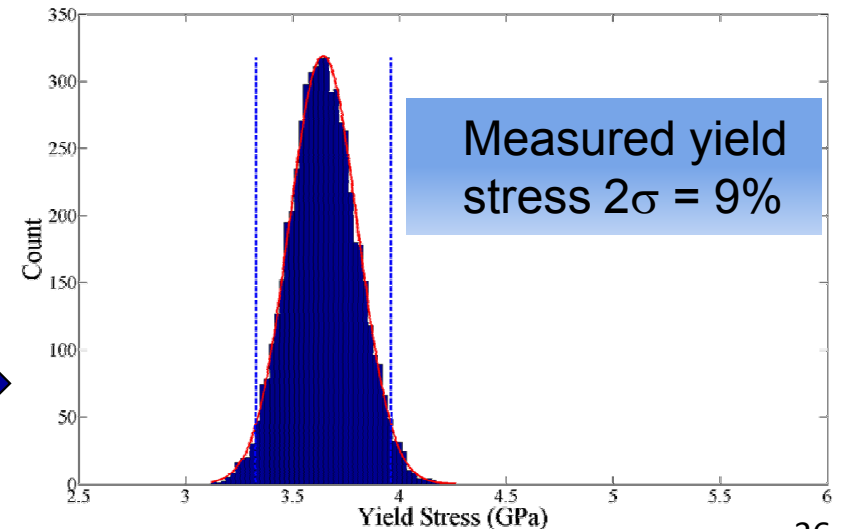
$$Y = Y_0 [1 + \beta(\varepsilon + \varepsilon_i)]^n \left[1 + A \frac{P}{\eta^{1/3}} + B(T - 300) \right]$$

10,000 Runs later, distributions are obtained for Y and P

Simulated peak yield stress
 $2\sigma = 25\%$

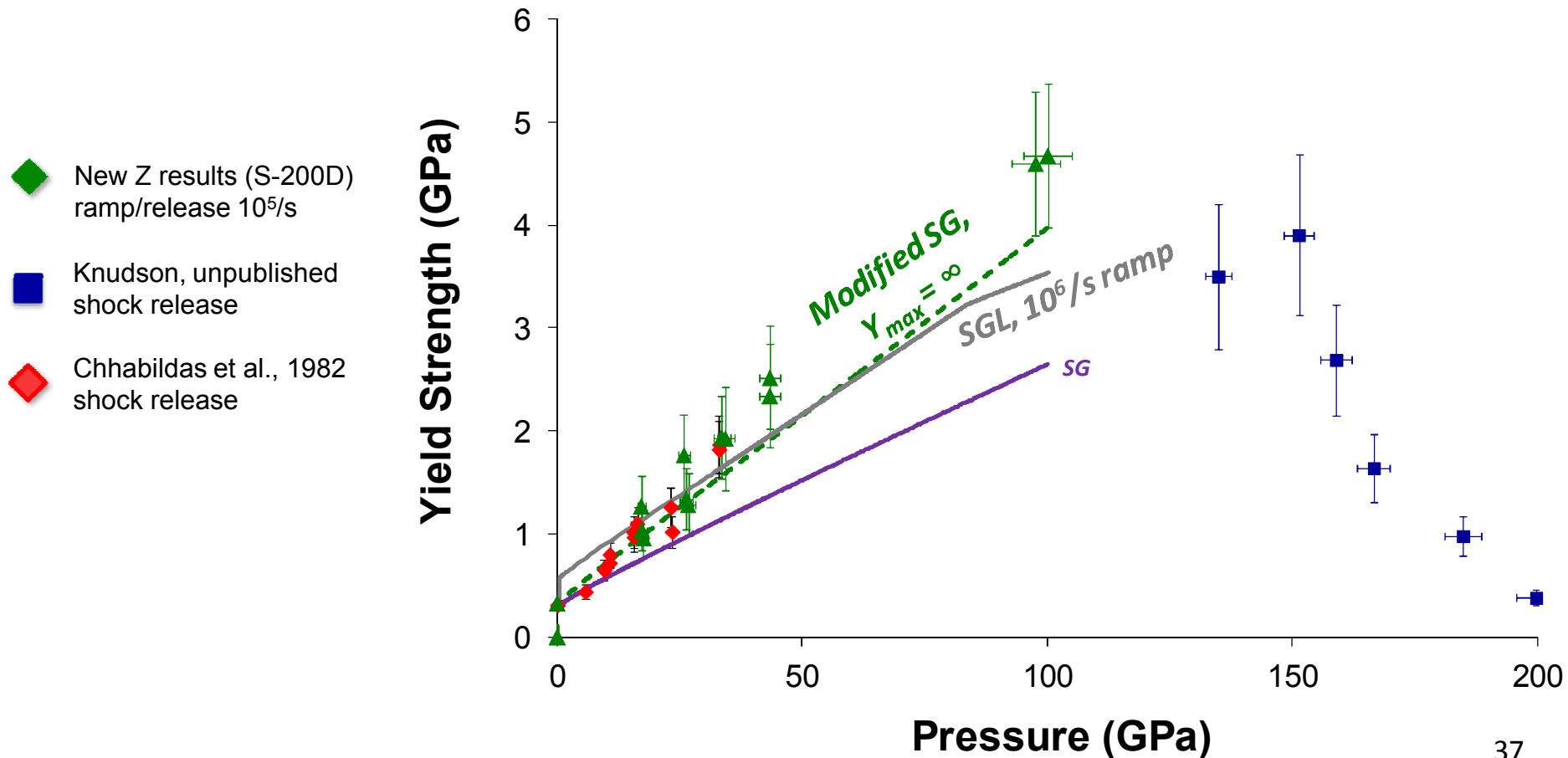


Transfer function/strength analysis applied to each simulation



Beryllium strength

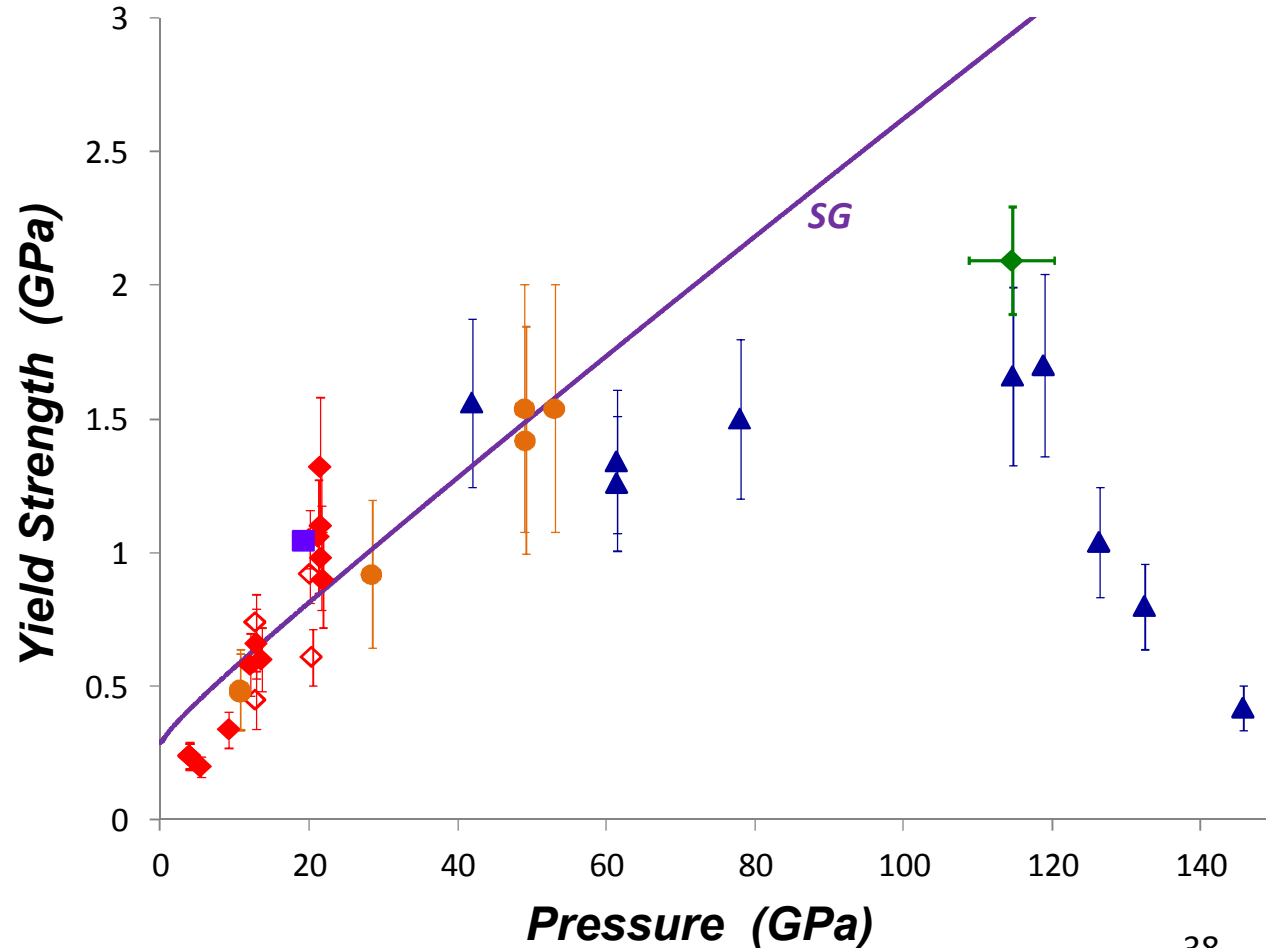
- Shock data in good agreement with ramp until thermal softening decreases the strength approaching shock melt.



Aluminum strength

- Shock, ramp, RT data all in good agreement

- ◆ New Z results (6061-T6)
ramp/release $10^5/s$
- Vogler et al., 2008
ramp/release $10^5/s$
- Lorentz et al., 2005
Rayleigh-Taylor ramp $10^7/s$
- ▲ Reinhart, unpublished (6061-T6)
shock release/reload
- ◆ Huang et al., 2007 (single crystal)
shock release/reload
- ◇ Huang et al., 2005
shock release/reload



NNSA Ta characterization

